



*The Abdus Salam
International Centre for Theoretical Physics*



1936-6

**Advanced School on Synchrotron and Free Electron Laser Sources
and their Multidisciplinary Applications**

7 - 25 April 2008

Spatial and Temporal Coherence, Coherent Undulator Radiation

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Spatial and Temporal Coherence, Coherent Undulator Radiation

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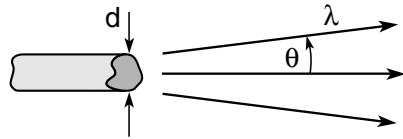
Topics for Today



- Spatial coherence
- Temporal coherence
- Partial coherence
- Full coherence
- Spatial filtering
- Uncorrelated emitters
- Correlated emitters
- True phase coherence and mode control
- Lasers, amplified spontaneous emission (ASE) and mode control
- Undulator radiation
- SASE FEL
- Seeded FEL
- High harmonic generation (HHG)
- EUV lasers and laser seeded HHG
- Applications with uncorrelated emitters
- Applications with correlated emitters



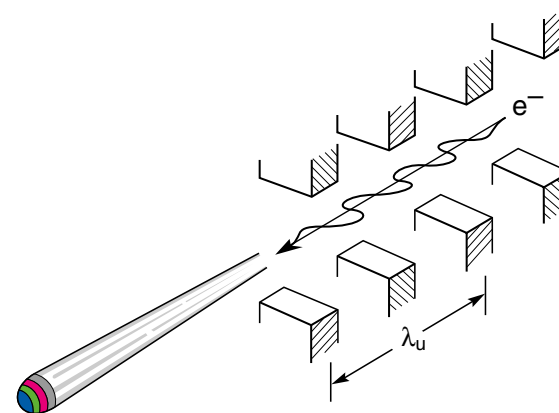
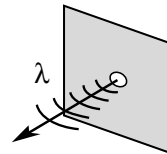
COHERENCE AT SHORT WAVELENGTHS



$$l_{\text{coh}} = \lambda^2 / 2\Delta\lambda \quad \{\text{temporal (longitudinal) coherence}\} \quad (8.3)$$

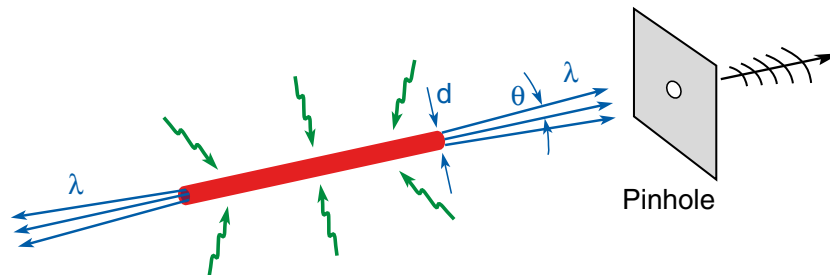
$$d \cdot \theta = \lambda / 2\pi \quad \{\text{spatial (transverse) coherence}\} \quad (8.5)$$

$$\text{or } d \cdot 2\theta|_{\text{FWHM}} = 0.44 \lambda \quad (8.5^*)$$



$$\bar{P}_{\text{coh},N} = \frac{(\lambda/2\pi)^2}{(d_x\theta_x)(d_y\theta_y)} \bar{P}_{\text{cen}} \quad (8.6)$$

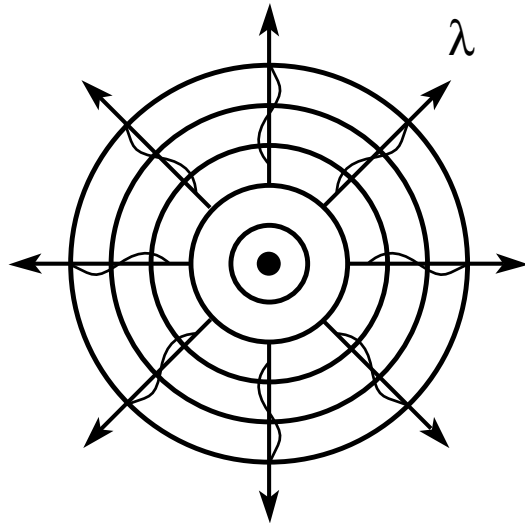
$$\bar{P}_{\text{coh},\lambda/\Delta\lambda} = \frac{e\lambda_u I \eta (\Delta\lambda/\lambda) N^2}{8\pi\epsilon_0 d_x d_y} \cdot \left[1 - \frac{\hbar\omega}{\hbar\omega_0} \right] f(K) \quad (8.9)$$



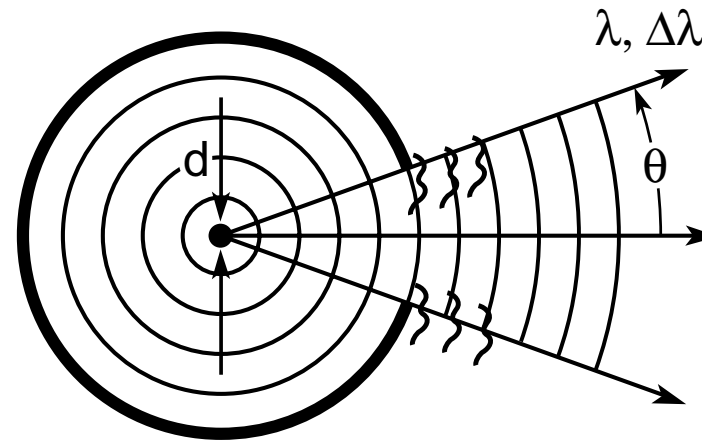
$$P_{\text{coh}} = \frac{(\lambda/2\pi)^2}{(d_x\theta_x)(d_y\theta_y)} P_{\text{laser}} \quad (8.11)$$



Coherence, Partial Coherence, and Incoherence



Point source oscillator
 $-\infty < t < \infty$



Source of finite size,
divergence, and duration



Spatial and Temporal Coherence

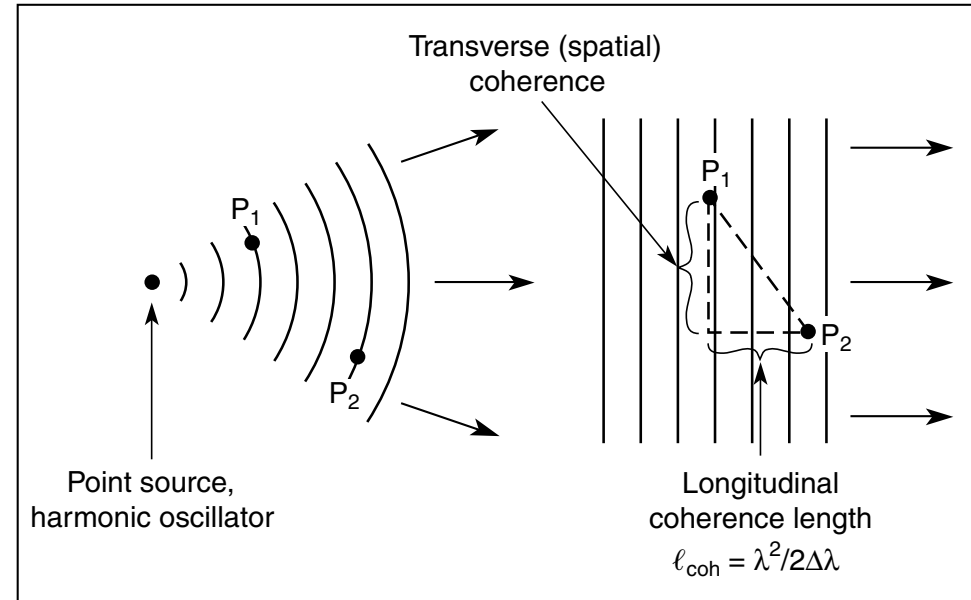
Mutual coherence factor

$$\Gamma_{12}(\tau) \equiv \langle E_1(t + \tau) E_2^*(t) \rangle \quad (8.1)$$

Normalize degree of spatial coherence
(complex coherence factor)

$$\mu_{12} = \frac{\langle E_1(t) E_2^*(t) \rangle}{\sqrt{\langle |E_1|^2 \rangle} \sqrt{\langle |E_2|^2 \rangle}} \quad (8.12)$$

A high degree of coherence ($\mu \rightarrow 1$) implies an ability to form a high contrast interference (fringe) pattern. A low degree of coherence ($\mu \rightarrow 0$) implies an absence of interference, except with great care. In general radiation is partially coherent.



Longitudinal (temporal) coherence length

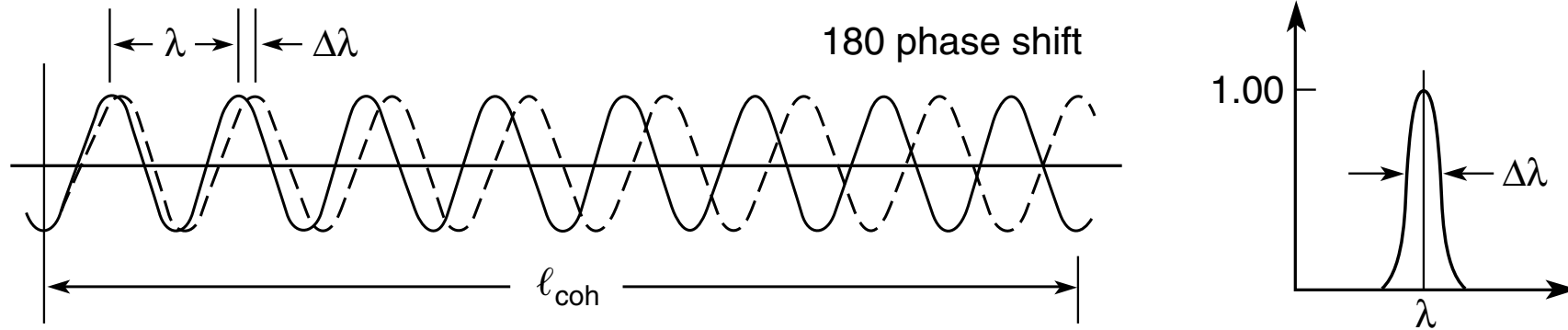
$$\ell_{\text{coh}} = \frac{\lambda^2}{2 \Delta \lambda} \quad (8.3)$$

Full spatial (transverse) coherence

$$d \cdot \theta = \lambda / 2\pi \quad (8.5)$$



Spectral Bandwidth and Longitudinal Coherence Length



Define a coherence length ℓ_{coh} as the distance of propagation over which radiation of spectral width $\Delta\lambda$ becomes 180° out of phase. For a wavelength λ propagating through N cycles

$$\ell_{\text{coh}} = N\lambda$$

and for a wavelength $\lambda + \Delta\lambda$, a half cycle less $(N - \frac{1}{2})$

$$\ell_{\text{coh}} = (N - \frac{1}{2}) (\lambda + \Delta\lambda)$$

Equating the two

$$N = \lambda / 2\Delta\lambda$$

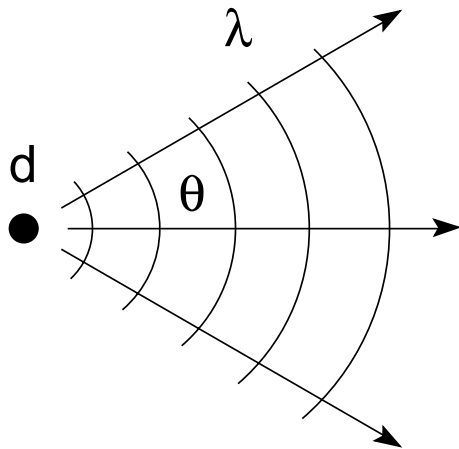
so that

$$\boxed{\ell_{\text{coh}} = \frac{\lambda^2}{2 \Delta\lambda}} \quad (8.3)$$



A Practical Interpretation of Spatial Coherence

- Associate spatial coherence with a spherical wavefront.
- A spherical wavefront implies a point source.
- How small is a “point source”?



From Heisenberg's Uncertainty Principle ($\Delta x \cdot \Delta p \geq \frac{\hbar}{2}$), the smallest source size “ d ” you can resolve, with wavelength λ and half angle θ , is

$$d \cdot \theta = \frac{\lambda}{2\pi}$$



Partially Coherent Radiation Approaches Uncertainty Principle Limits

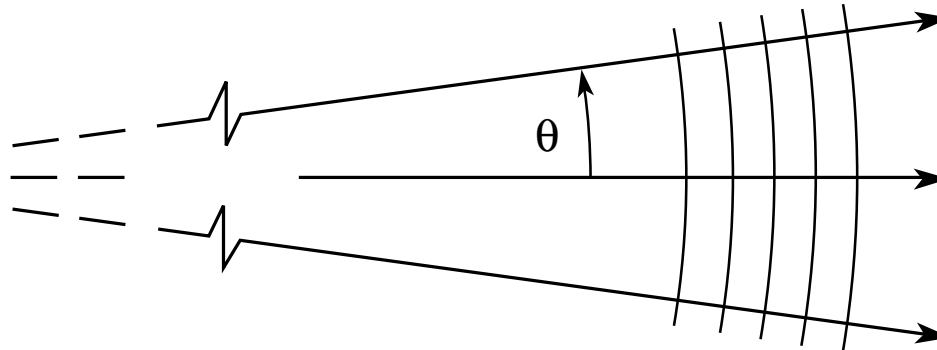
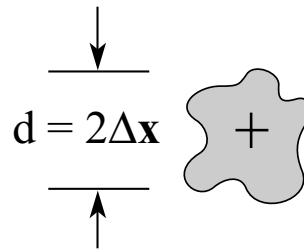
$$\Delta \mathbf{x} \cdot \Delta \mathbf{p} \geq \hbar/2 \quad (8.4)$$

Standard deviations of Gaussian distributed functions
(Tipler, 1978, pp. 174-189)

$$\Delta \mathbf{x} \cdot \hbar \Delta \mathbf{k} \geq \hbar/2$$

$$\Delta \mathbf{x} \cdot \mathbf{k} \Delta \theta \geq 1/2$$

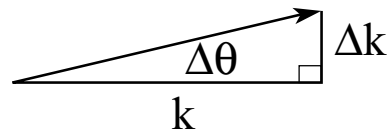
$$2\Delta \mathbf{x} \cdot \Delta \theta \geq \lambda/2\pi$$



Note:

$$\Delta \mathbf{p} = \hbar \Delta \mathbf{k}$$

$$\Delta \mathbf{k} = \mathbf{k} \Delta \theta$$

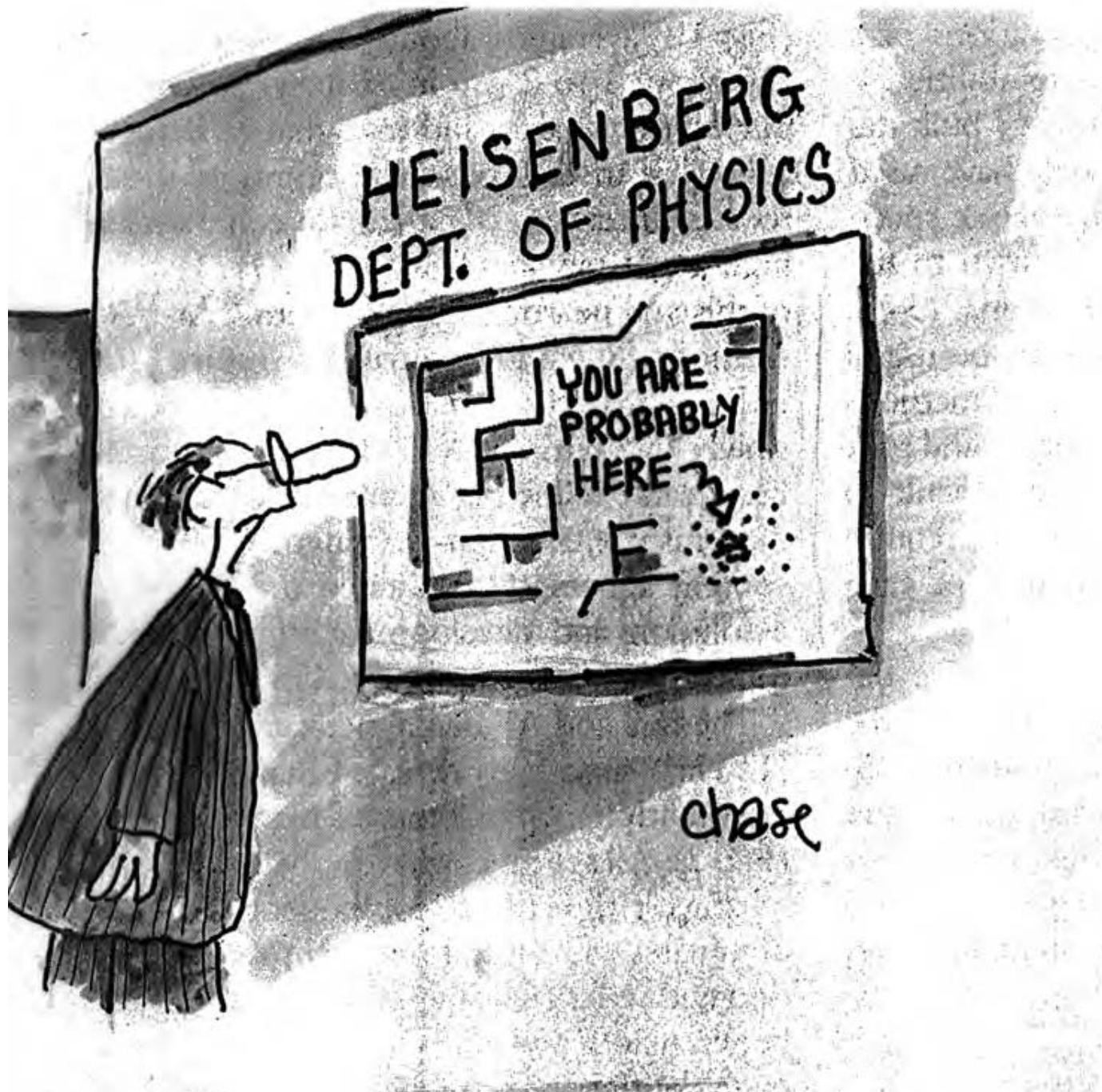


Spherical wavefronts occur
in the limiting case

$$\left. \begin{array}{l} d \cdot \theta = \lambda/2\pi \\ \text{(spatially coherent)} \end{array} \right\} \frac{1}{\sqrt{e}} \text{ quantities}$$

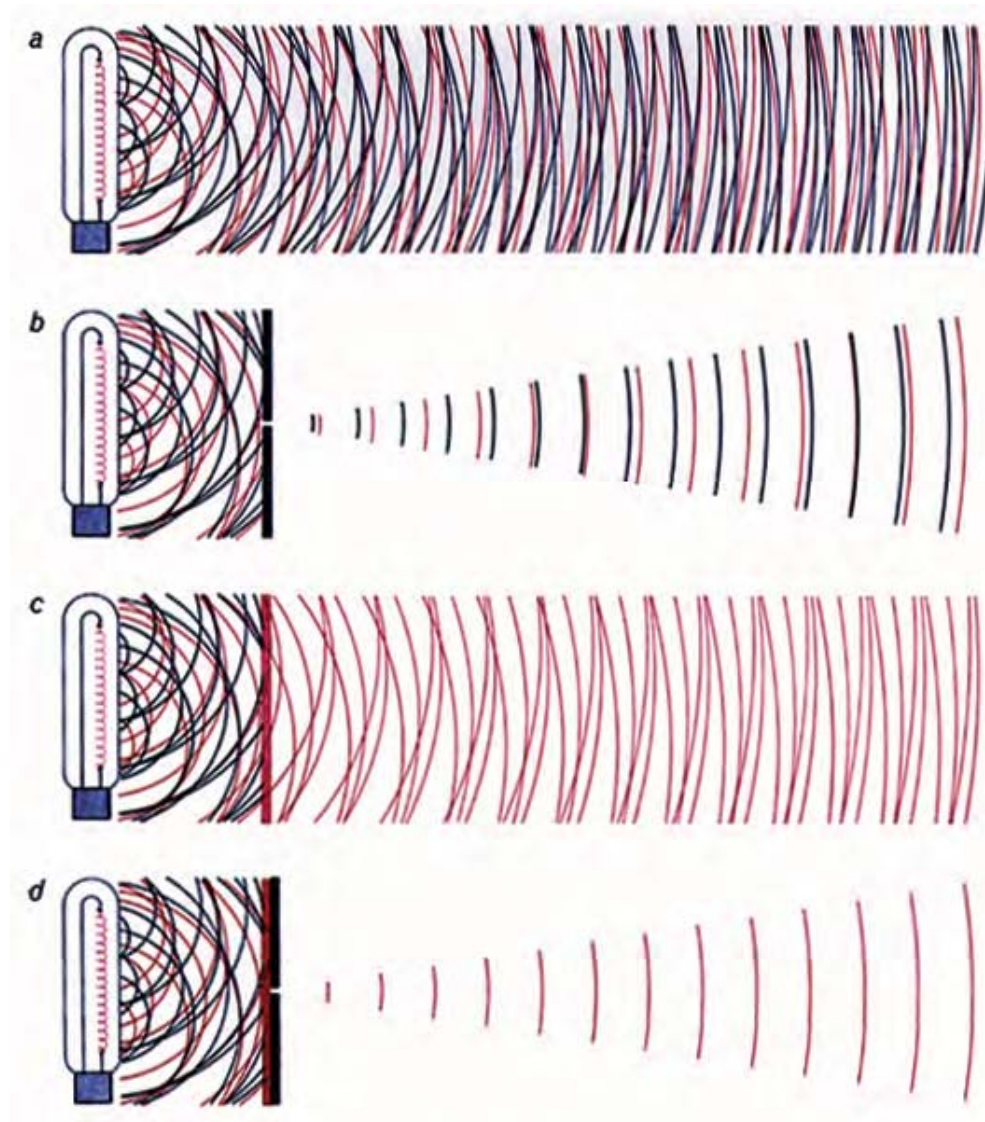
or

$$(d \cdot 2\theta)_{\text{FWHM}} \approx \lambda/2 \} \text{ FWHM quantities}$$





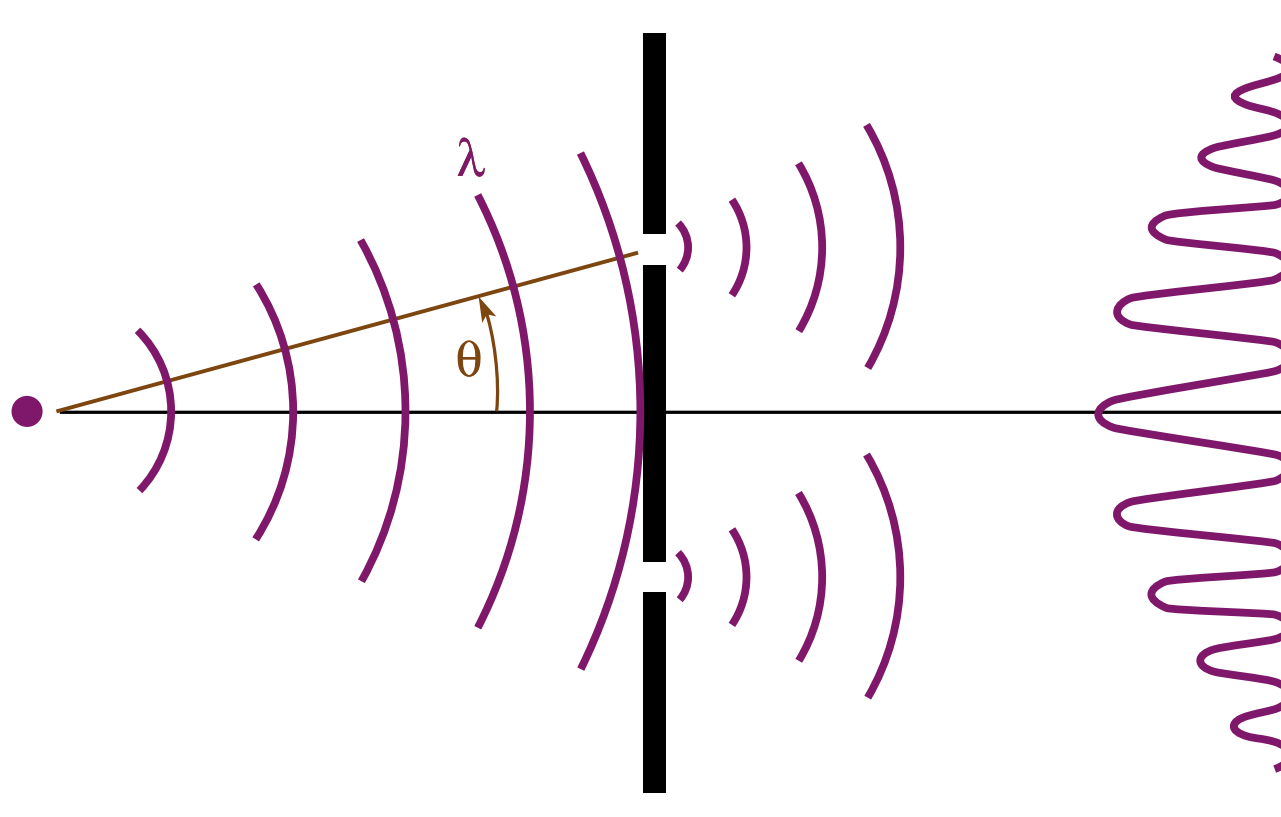
Spatial and Spectral Filtering to Produce Coherent Radiation



Courtesy of A. Schawlow, Stanford.



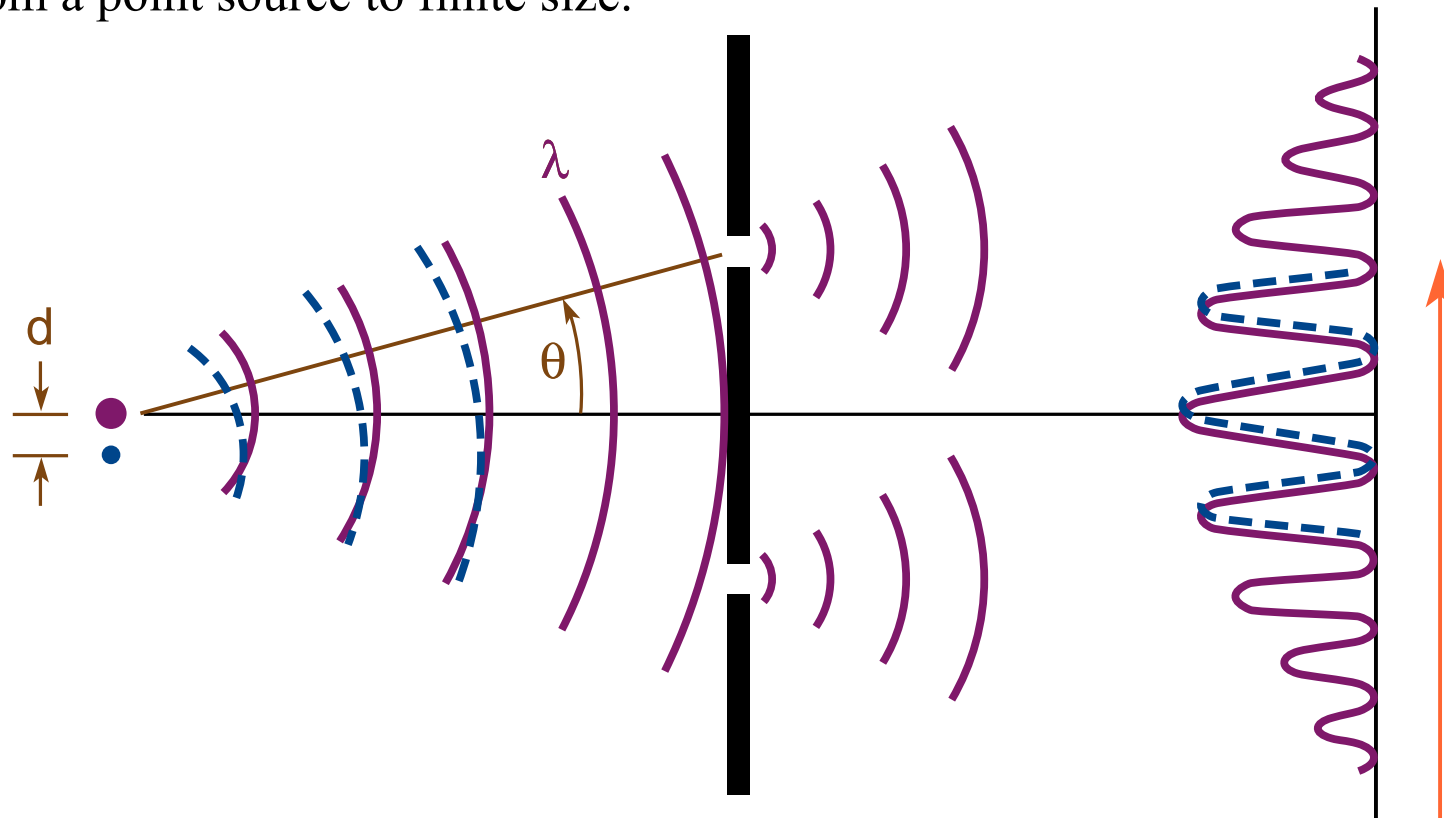
Young's Double Slit Experiment: Spatial Coherence and the Persistence of Fringes





Young's Double Slit Experiment: Spatial Coherence and the Persistence of Fringes

Persistence of fringes as the source grows from a point source to finite size.

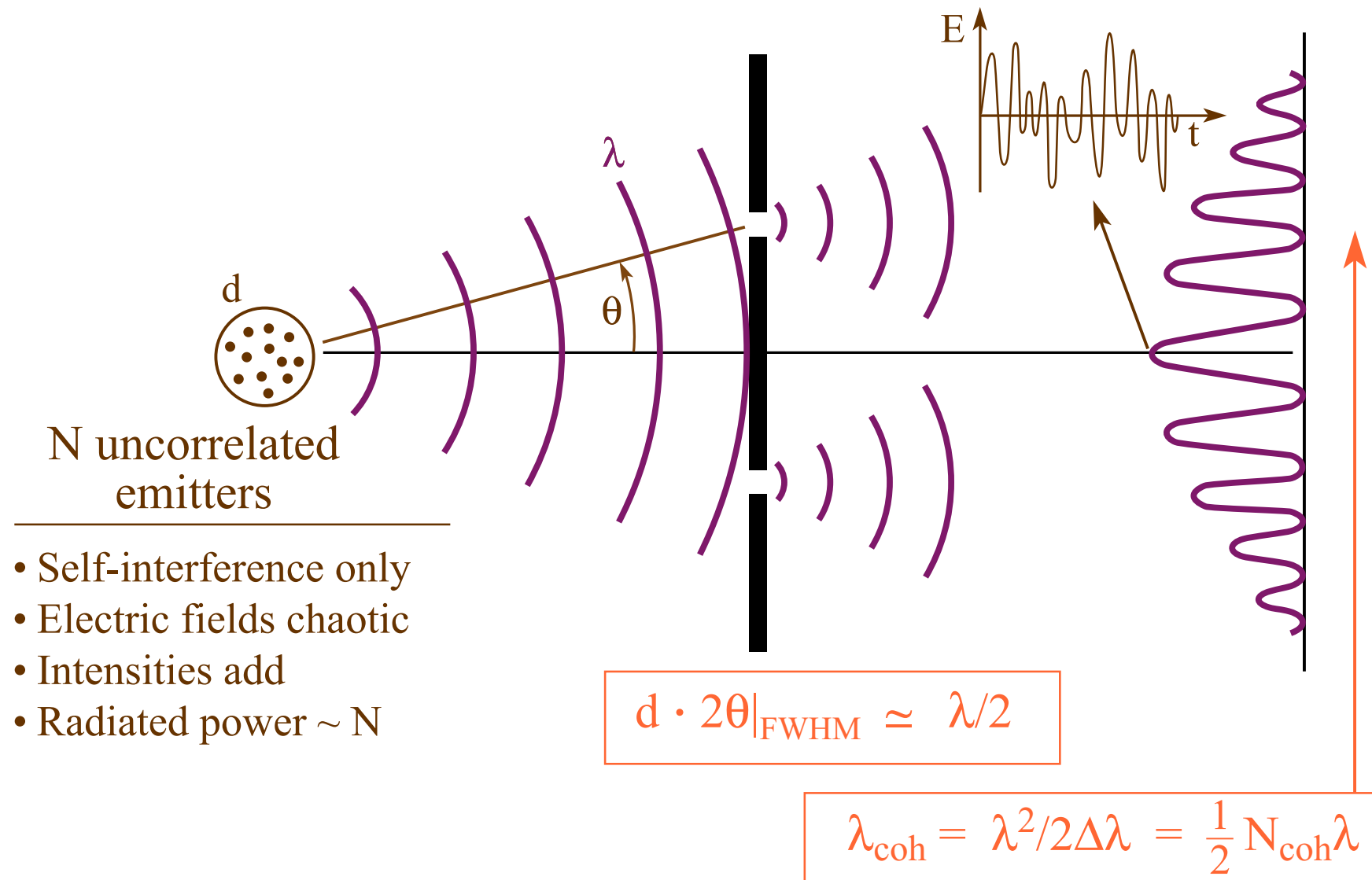


$$d \cdot 2\theta|_{\text{FWHM}} \approx \lambda/2$$

$$\lambda_{\text{coh}} = \lambda^2 / 2\Delta\lambda = \frac{1}{2} N_{\text{coh}} \lambda$$

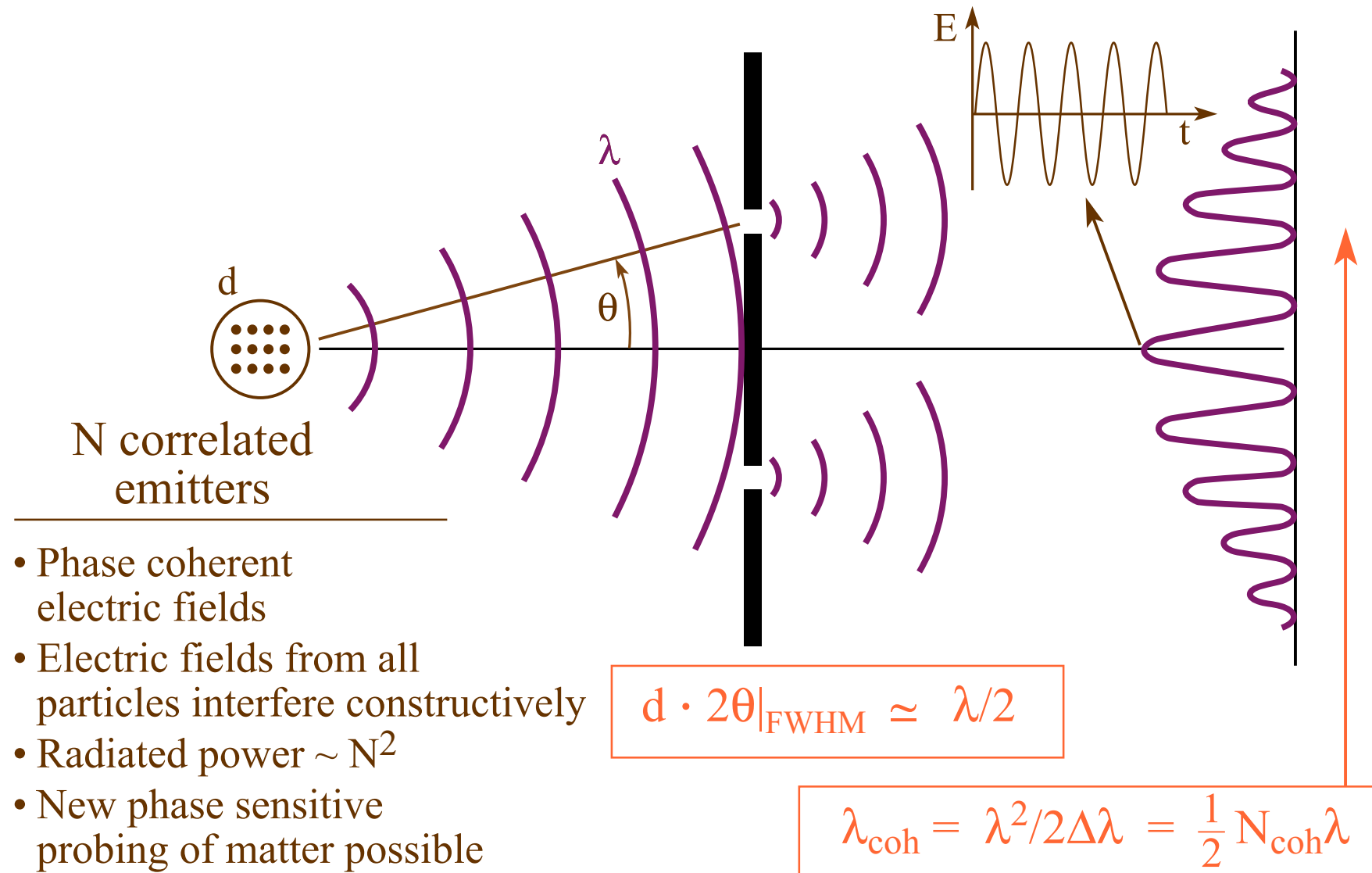


Young's Double Slit Experiment with Random Emitters: Young did not have a laser



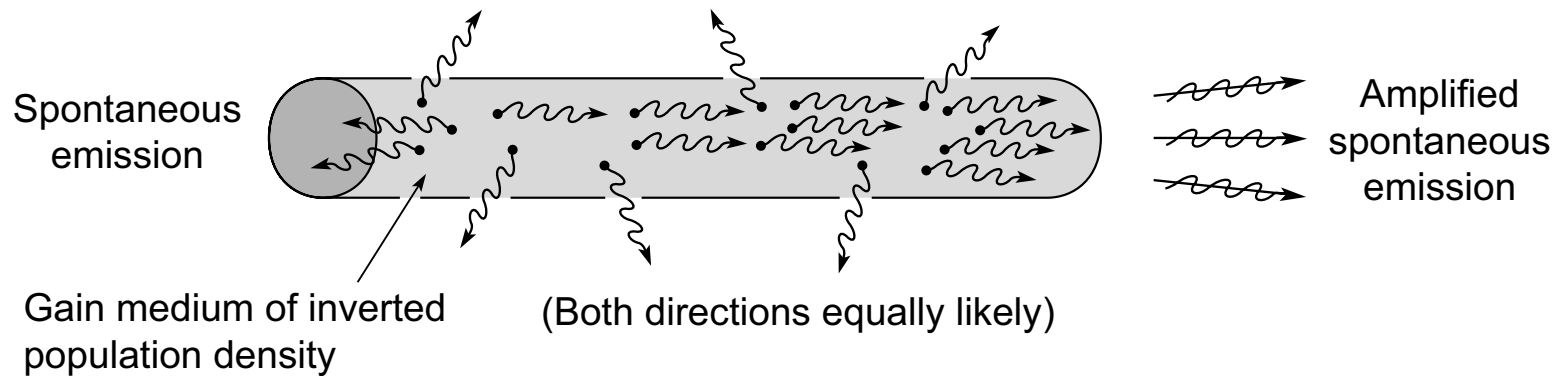


Young's Double Slit Experiment with Phase Coherent Emitters (some lasers, or properly seeded FELs)

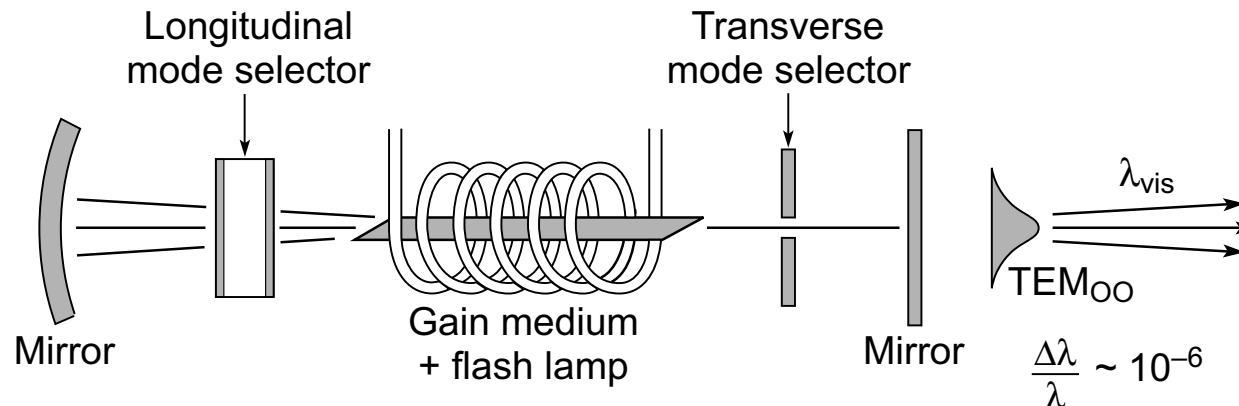




The Lasing Process Begins with Amplified Spontaneous Emission (ASE)



but with spatial and temporal filtering, true phase coherence and mode control can be achieved.





Some Useful Formulas for Synchrotron Radiation



$$\gamma = \frac{1}{\sqrt{1 - \frac{v^2}{c^2}}} = \frac{1}{\sqrt{1 - \beta^2}} ; \quad \beta = \frac{v}{c}$$

$$E_e = \gamma mc^2, \quad \mathbf{p} = \gamma m \mathbf{v}$$

$$\gamma = \frac{E_e}{mc^2} = 1957 E_e(\text{GeV})$$

$$\hbar\omega \cdot \lambda = 1239.842 \text{ eV} \cdot \text{nm}$$

$$1 \text{ watt} \Rightarrow 5.034 \times 10^{15} \lambda[\text{nm}] \frac{\text{photons}}{\text{s}}$$

$$\text{Bending Magnet: } E_c = \frac{3e\hbar B\gamma^2}{2m}, \quad E_c(\text{keV}) = 0.6650 E_e^2(\text{GeV}) B(\text{T})$$

$$\text{Undulator: } \lambda = \frac{\lambda_u}{2\gamma^2} \left(1 + \frac{K^2}{2} + \gamma^2 \theta^2 \right); \quad E(\text{keV}) = \frac{0.9496 E_e^2(\text{GeV})}{\lambda_u(\text{cm}) \left(1 + \frac{K^2}{2} + \gamma^2 \theta^2 \right)}$$

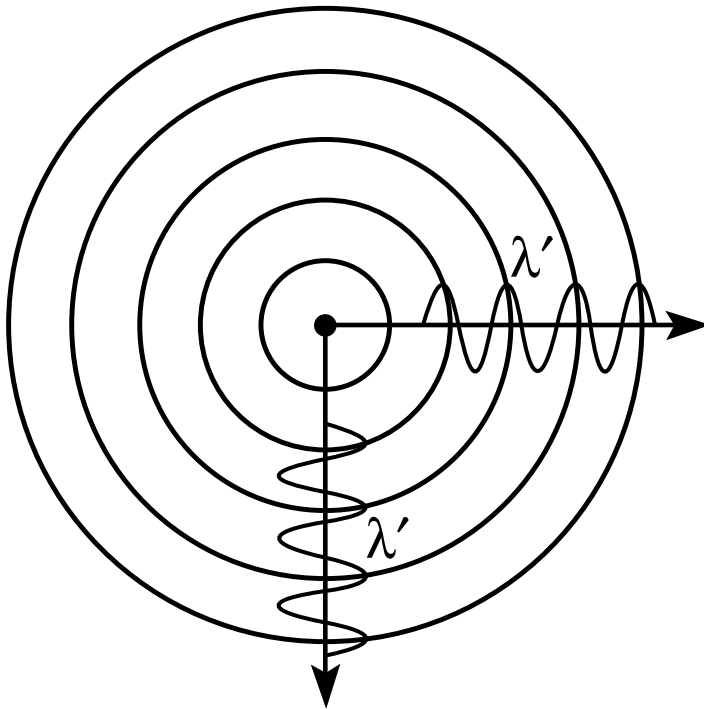
$$\text{where } K \equiv \frac{eB_0\lambda_u}{2\pi mc} = 0.9337 B_0(\text{T}) \lambda_u(\text{cm})$$



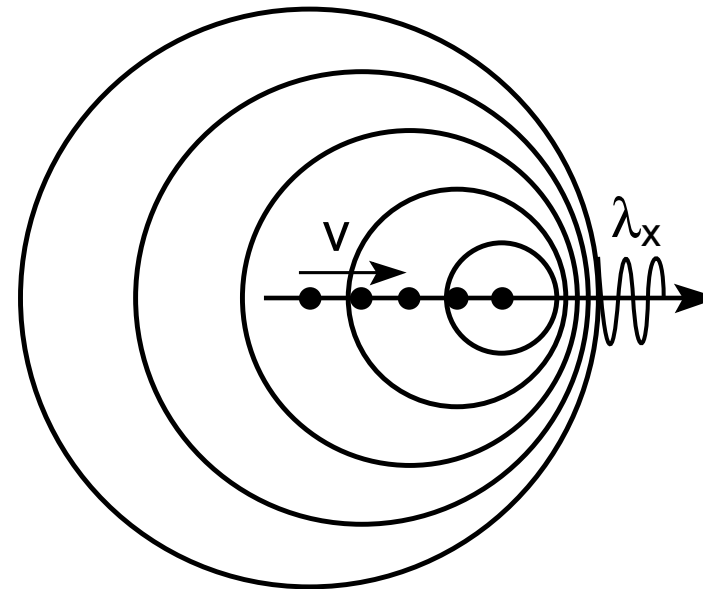
Synchrotron Radiation from Relativistic Electrons



$v \ll c$



$v \lesssim c$



Note: Angle-dependent doppler shift

$$\lambda = \lambda' \left(1 - \frac{v}{c} \cos\theta\right) \quad \lambda = \lambda' \gamma \left(1 - \frac{v}{c} \cos\theta\right)$$

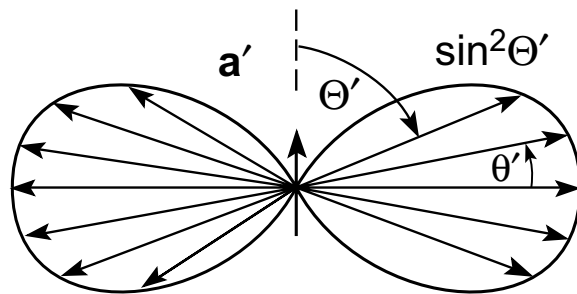
$$\gamma = \frac{1}{\sqrt{1 - \frac{v^2}{c^2}}}$$



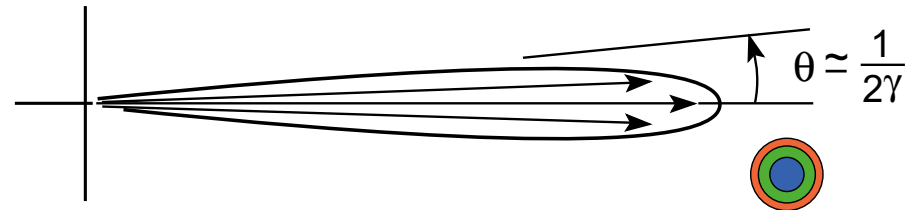
Synchrotron Radiation in a Narrow Forward Cone



Frame moving with electron



Laboratory frame of reference

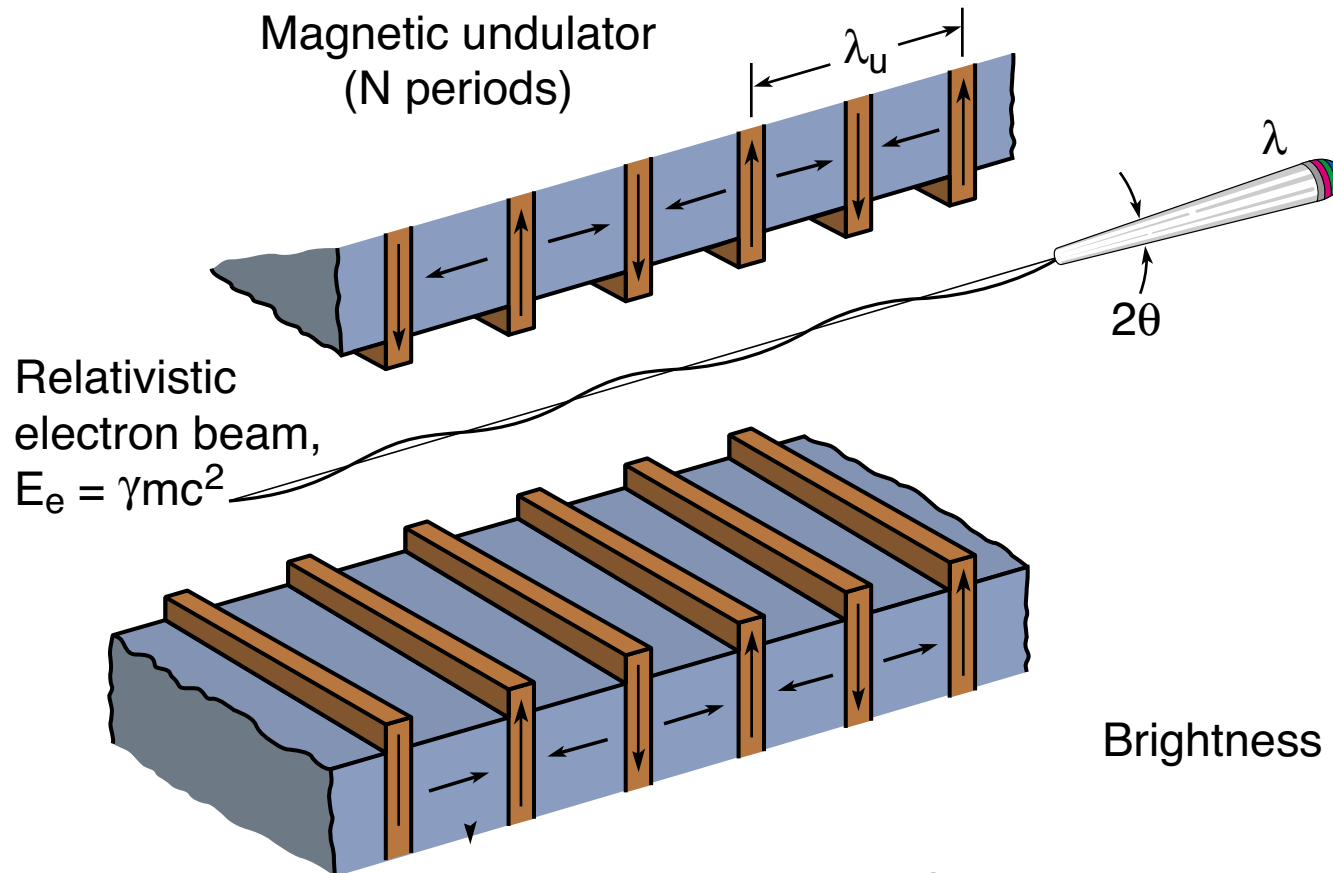


$$\tan \theta = \frac{\sin \theta'}{\gamma(\beta + \cos \theta')} \quad (5.1)$$

$$\theta \simeq \frac{1}{2\gamma} \quad (5.2)$$



Undulator Radiation from a Small Electron Beam Radiating into a Narrow Forward Cone, is Very Bright



$$\lambda \approx \frac{\lambda_u}{2\gamma^2}$$

$$\theta_{\text{cen}} \approx \frac{1}{\gamma \sqrt{N}}$$

$$\left[\frac{\Delta\lambda}{\lambda} \right]_{\text{cen}} = \frac{1}{N}$$

$$\text{Brightness} = \frac{\text{photon flux}}{(\Delta A) (\Delta\Omega)}$$

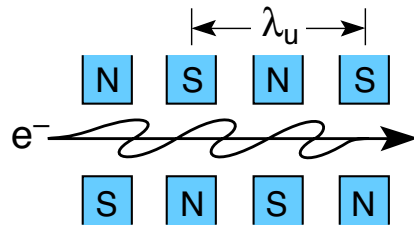
$$\text{Spectral Brightness} = \frac{\text{photon flux}}{(\Delta A) (\Delta\Omega) (\Delta\lambda/\lambda)}$$



Undulator Radiation



Laboratory Frame of Reference

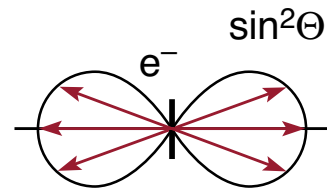


$$E = \gamma mc^2$$

$$\gamma = \frac{1}{\sqrt{1 - \frac{v^2}{c^2}}}$$

$N = \#$ periods

Frame of Moving e^-



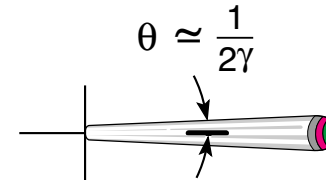
e^- radiates at the Lorentz contracted wavelength:

$$\lambda' = \frac{\lambda_u}{\gamma}$$

Bandwidth:

$$\frac{\lambda'}{\Delta\lambda'} \approx N$$

Frame of Observer



Doppler shortened wavelength on axis:

$$\lambda = \lambda' \gamma (1 - \beta \cos \theta)$$

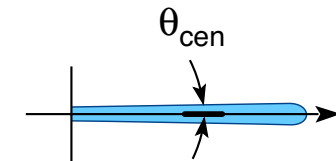
$$\lambda = \frac{\lambda_u}{2\gamma^2} (1 + \gamma^2 \theta^2)$$

Accounting for transverse motion due to the periodic magnetic field:

$$\lambda = \frac{\lambda_u}{2\gamma^2} \left(1 + \frac{K^2}{2} + \gamma^2 \theta^2 \right)$$

where $K = eB_0\lambda_u / 2\pi mc$

Following Monochromator



$$\text{For } \frac{\Delta\lambda}{\lambda} \approx \frac{1}{N}$$

$$\theta_{\text{cen}} \approx \frac{1}{\gamma\sqrt{N}}$$

typically

$$\theta_{\text{cen}} \approx 40 \text{ rad}$$



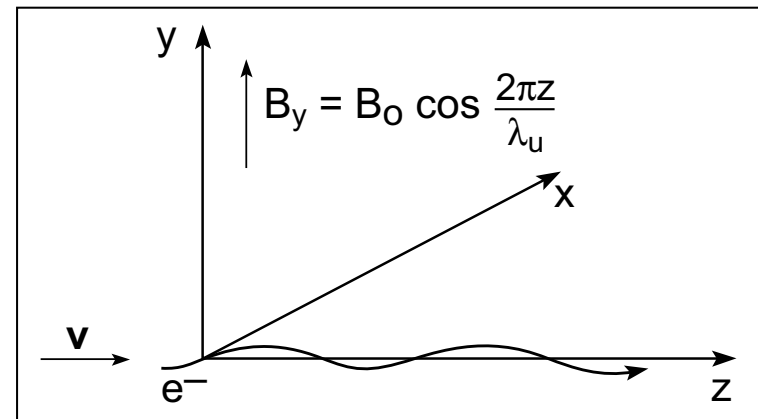
The Equation of Motion in an Undulator

Magnetic fields in the periodic undulator cause the electrons to oscillate and thus radiate. These magnetic fields also slow the electrons axial (z) velocity somewhat, reducing both the Lorentz contraction and the Doppler shift, so that the observed radiation wavelength is not quite so short. The force equation for an electron is

$$\frac{d\mathbf{p}}{dt} = -e(\mathbf{E} + \mathbf{v} \times \mathbf{B}) \quad (5.16)$$

where $\mathbf{p} = \gamma m \mathbf{v}$ is the momentum. The radiated fields are relatively weak so that

$$\frac{d\mathbf{p}}{dt} \simeq -e(\mathbf{v} \times \mathbf{B})$$



Taking to first order $v \simeq v_z$, motion in the x-direction is

$$m\gamma \frac{dv_x}{dt} = +ev_z B_y$$

$$v_x = \frac{Kc}{\gamma} \sin\left(\frac{2\pi z}{\lambda_u}\right) \quad (5.19)$$

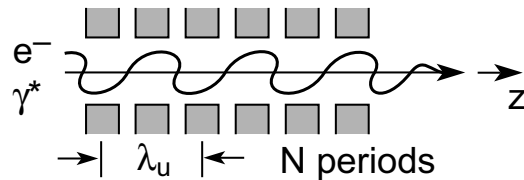
$$K \equiv \frac{eB_0\lambda_u}{2\pi mc} = 0.9337 B_0(\text{T})\lambda_u(\text{cm}) \quad (5.18)$$



Calculating Power in the Central Radiation Cone: Using the well known “dipole radiation” formula by transforming to the frame of reference moving with the electrons

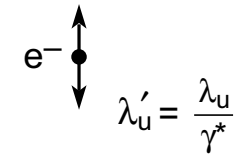


x, z, t laboratory frame of reference



Lorentz transformation

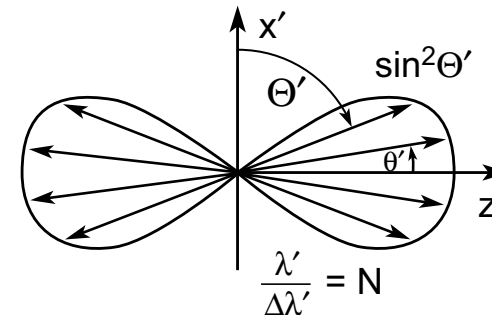
x', z', t' frame of reference moving with the average velocity of the electron



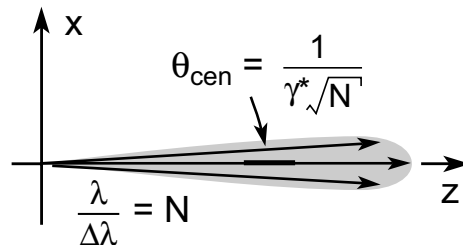
x', z', t' motion
 $a'(t')$ acceleration

Dipole radiation:

$$\frac{dP'}{d\Omega'} = \frac{e^2 a'^2 \sin^2 \Theta'}{16\pi^2 \epsilon_0 c^3}$$



Lorentz transformation



$$\bar{P}_{\text{cen}} = \frac{\pi e \gamma^2 I}{\epsilon_0 \lambda_u} \frac{K^2}{(1 + K^2/2)^2}$$



Undulator Radiated Power in the Central Cone

$$\lambda_x = \frac{\lambda_u}{2\gamma^2} \left(1 + \frac{K^2}{2} + \gamma^2\theta^2\right)$$

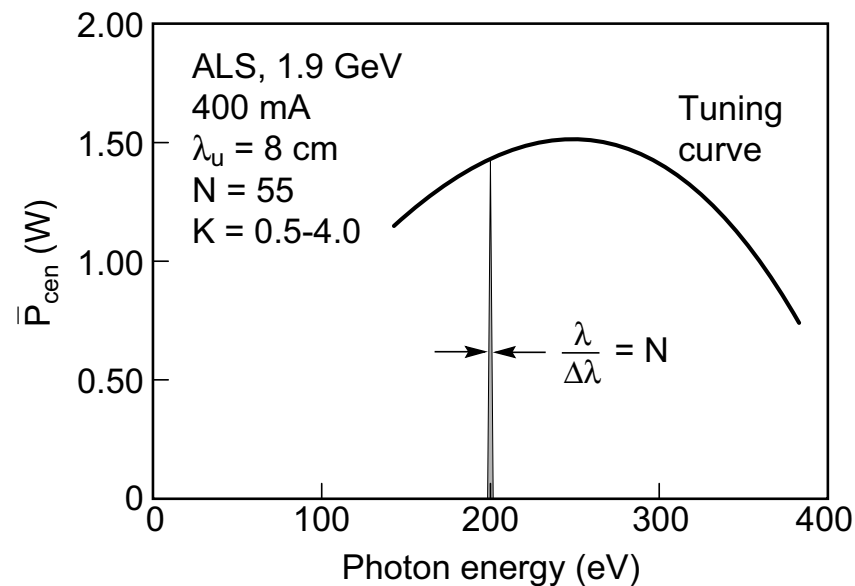
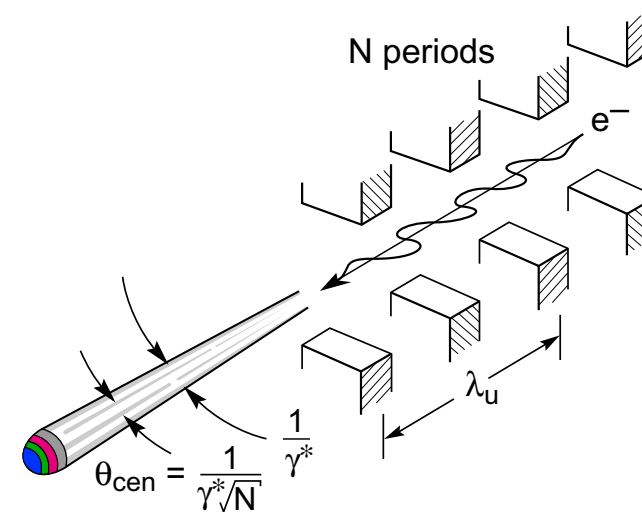
$$\bar{P}_{\text{cen}} = \frac{\pi e \gamma^2 I}{\epsilon_0 \lambda_u} \frac{K^2}{\left(1 + \frac{K^2}{2}\right)^2} f(K)$$

$$\theta_{\text{cen}} = \frac{1}{\gamma^* \sqrt{N}}$$

$$\left(\frac{\Delta\lambda}{\lambda}\right)_{\text{cen}} = \frac{1}{N}$$

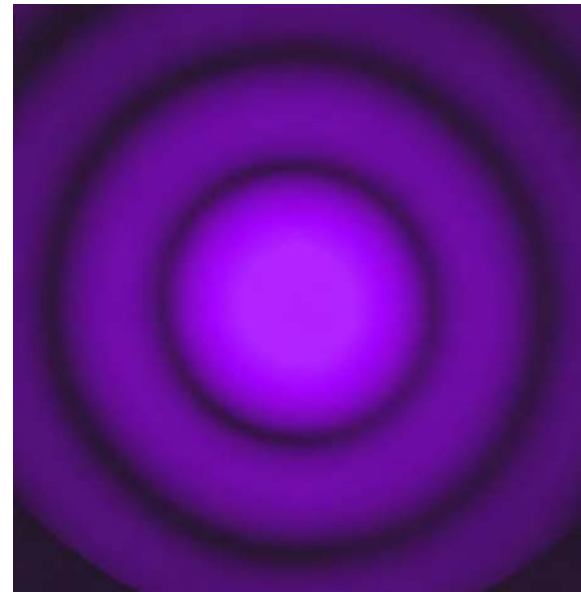
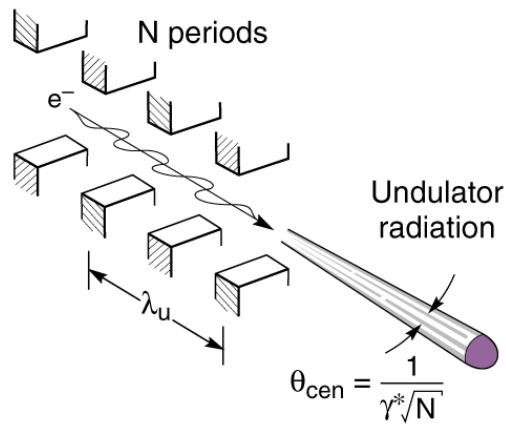
$$K = \frac{eB_0\lambda_u}{2\pi m_0 c}$$

$$\gamma^* = \gamma / \sqrt{1 + \frac{K^2}{2}}$$





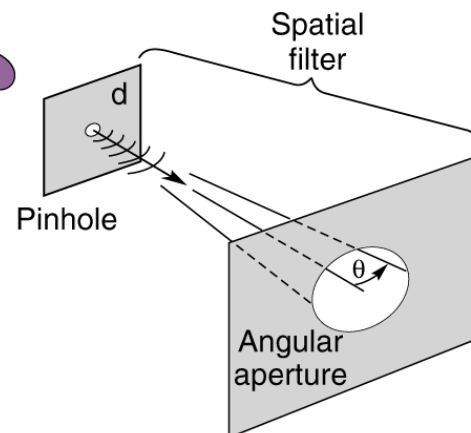
Spatially Coherent Undulator Radiation



$\lambda = 11.2 \text{ nm}$



$\lambda = 13.4 \text{ nm}$



1 μm^D pinhole

**25 mm wide CCD
at 410 mm**



Spatial and Spectral Filtering of Undulator Radiation

In addition to the pinhole – angular aperture for spatial filtering and spatial coherence, add a monochromator for narrowed bandwidth and increased temporal coherence:

$$\bar{P}_{\text{coh},\lambda/\Delta\lambda} = \underbrace{\eta}_{\text{beamline efficiency}} \underbrace{\frac{(\lambda/2\pi)^2}{(d_x\theta_x)(d_y,\theta_y)}}_{\text{spatial filtering}} \cdot \underbrace{N \frac{\Delta\lambda}{\lambda}}_{\text{spectral filtering}} \cdot \bar{P}_{\text{cen}} \quad (8.10a)$$

which for $\sigma'_{x,y} \ll \theta_{\text{cen}}^2$ (the undulator condition) gives the spatially and temporally coherent power ($d \cdot \theta = \lambda/2\pi$; $l_{\text{coh}} = \frac{\lambda^2}{2 \Delta\lambda}$)

$$\bar{P}_{\text{coh},\lambda/\Delta\lambda} = \frac{e\lambda_u I \eta (\Delta\lambda/\lambda) N^2}{8\pi\epsilon_0 d_x d_y} \cdot \left(1 - \frac{\hbar\omega}{\hbar\omega_0}\right) f(\hbar\omega/\hbar\omega_0) \quad (8.10c)$$

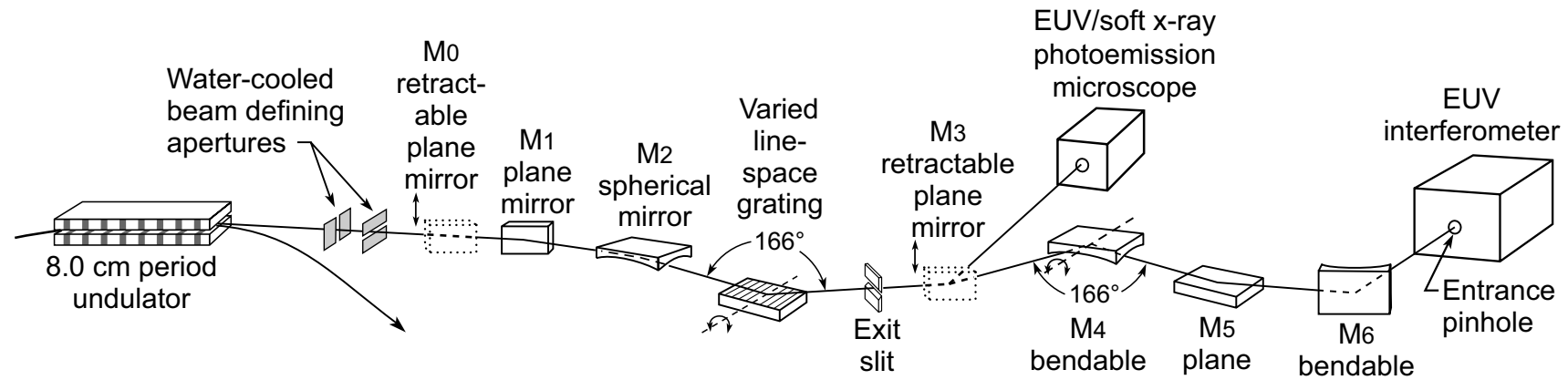
which we note scales as N^2 .



Spatially and Spectrally Filtered Undulator Radiation

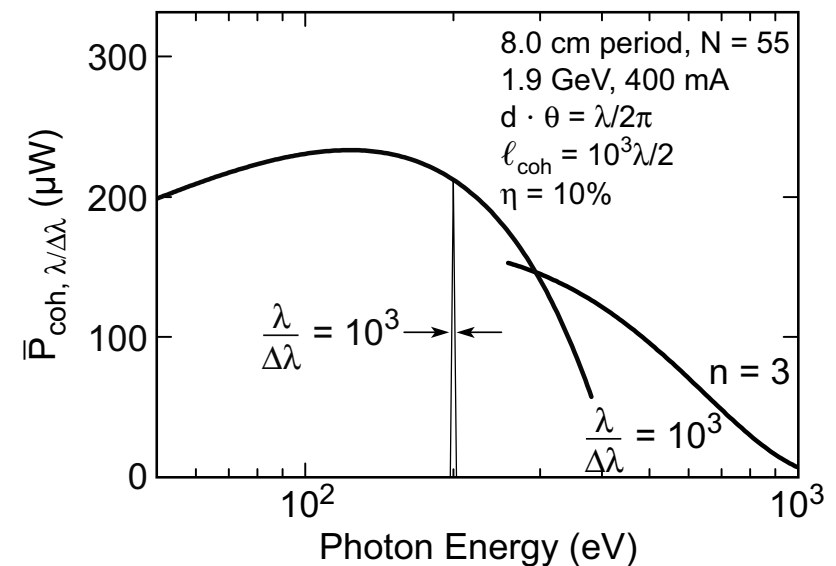


- Pinhole filtering for full spatial coherence
- Monochromator for spectral filtering to $\lambda/\Delta\lambda > N$



$$\bar{P}_{\text{coh}, \lambda/\Delta\lambda} = \underbrace{\eta}_{\text{beamline efficiency}} \underbrace{\frac{(\lambda/2\pi)^2}{(d_x \theta_x)(d_y \theta_y)}}_{\text{spatial filtering}} \cdot \underbrace{N \frac{\Delta\lambda}{\lambda}}_{\text{spectral filtering}} \cdot \bar{P}_{\text{cen}} \quad (8.10a)$$

$$\bar{P}_{\text{coh}, \lambda/\Delta\lambda} = \frac{e\lambda_u I \eta (\Delta\lambda/\lambda) N^2}{8\pi \epsilon_0 d_x d_y} \cdot \left(1 - \frac{\hbar\omega}{\hbar\omega_0}\right) f(\hbar\omega/\hbar\omega_0) \quad (\sigma'^2 \ll \theta_{\text{cen}}^2) \quad (8.10c)$$

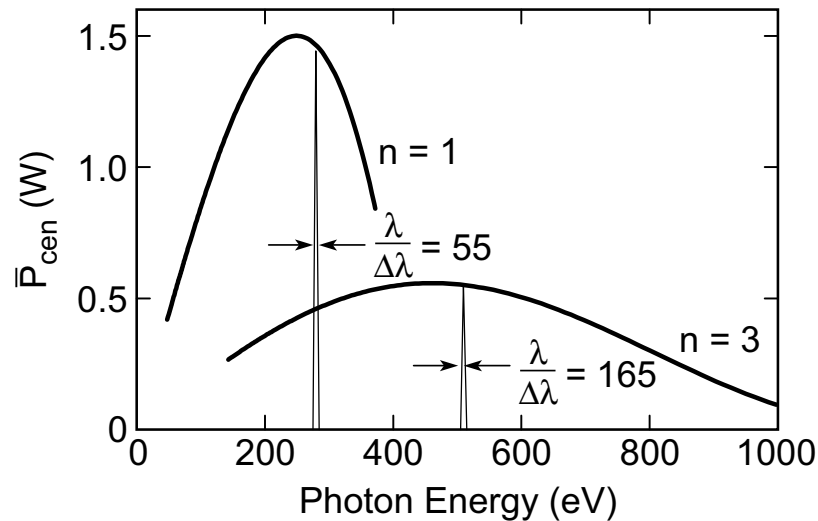




Coherent Power at the ALS



U8



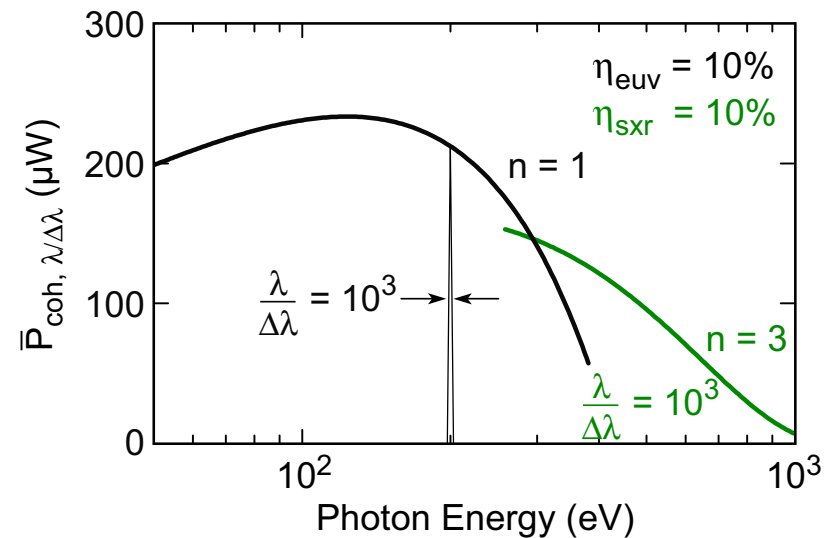
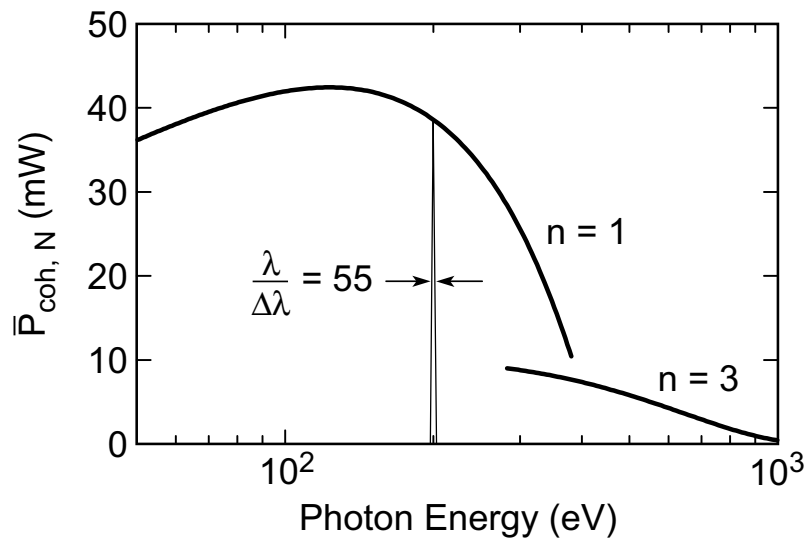
1.9 GeV, 400 mA

$\lambda_u = 80$ mm, $N = 55$

$0.5 \leq K \leq 4.0$

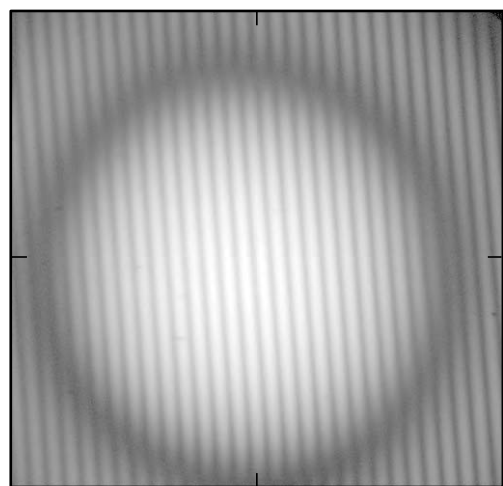
$\sigma_x = 260$ μm , $\sigma_x' = 23$ μr

$\sigma_y = 16$ μm , $\sigma_y' = 3.9$ μr

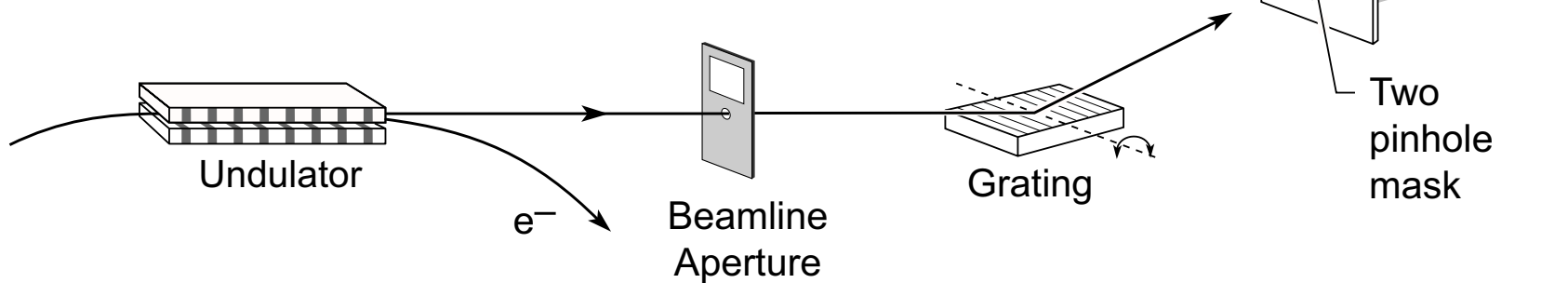
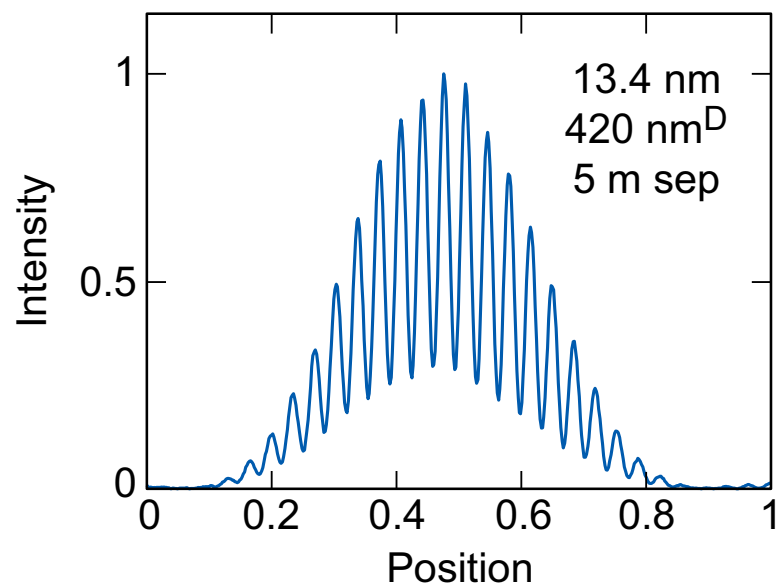




Measurement of Undulator Spatial Coherence



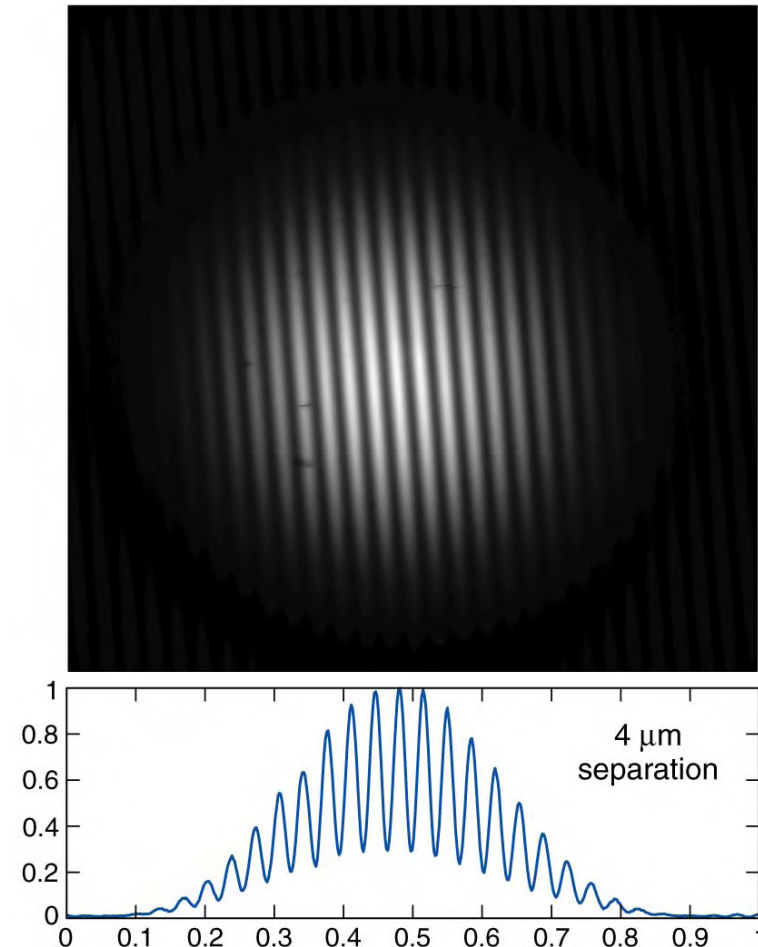
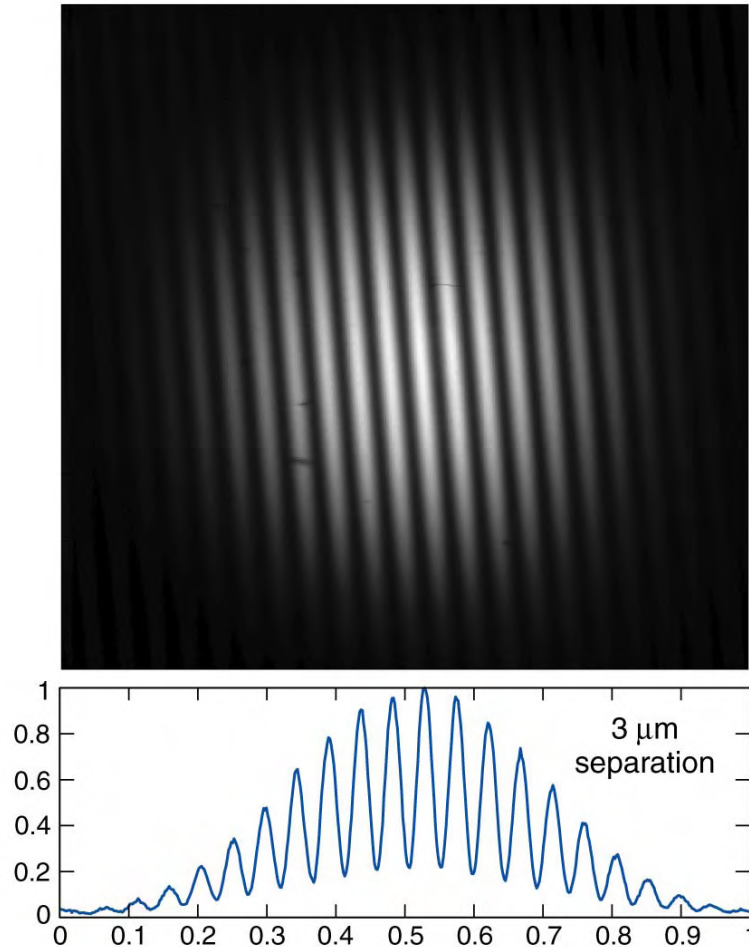
C. Chang



Courtesy of Chang Chang, UC Berkeley and LBNL.



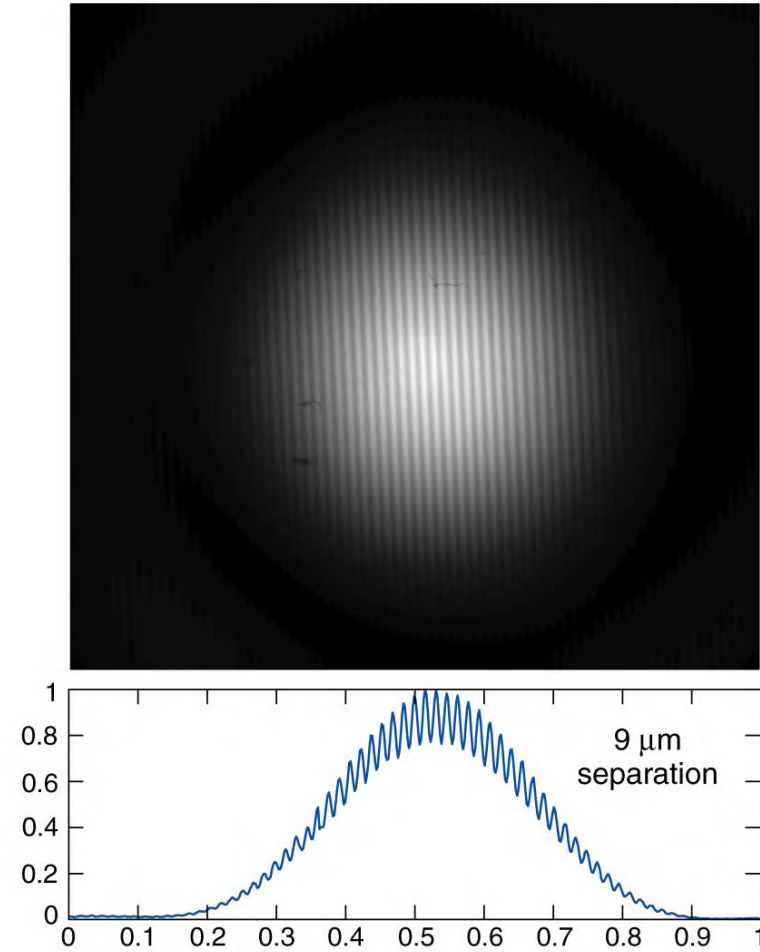
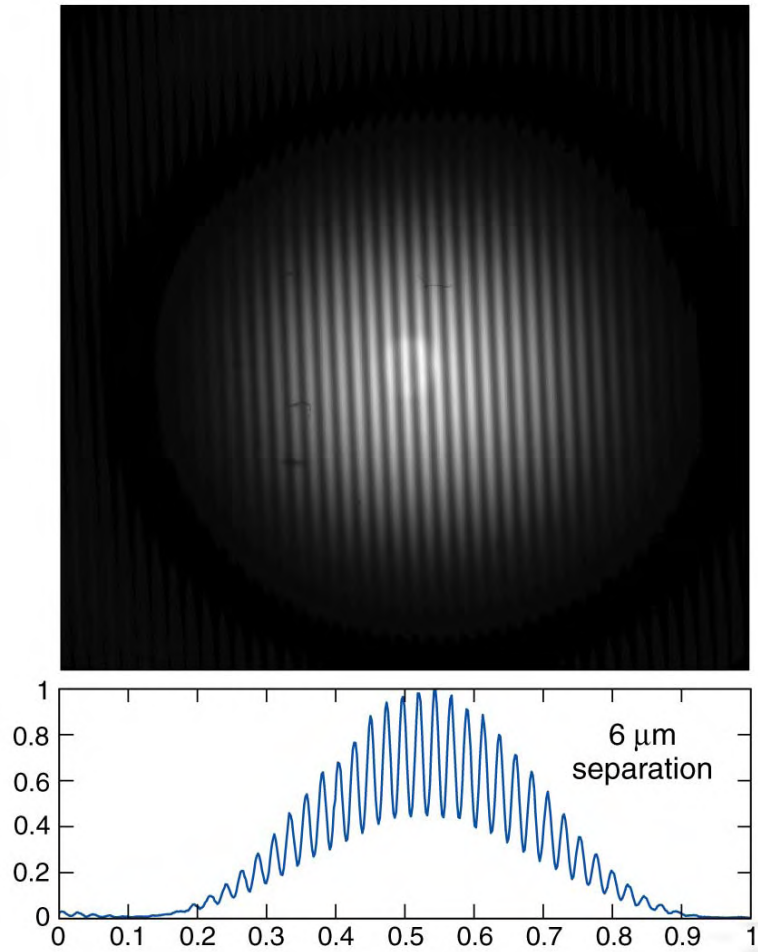
Spatial Coherence Measurements of Undulator Radiation Using the Classic 2-Pinhole Technique



Courtesy of Chang Chang, UC Berkeley and LBNL.



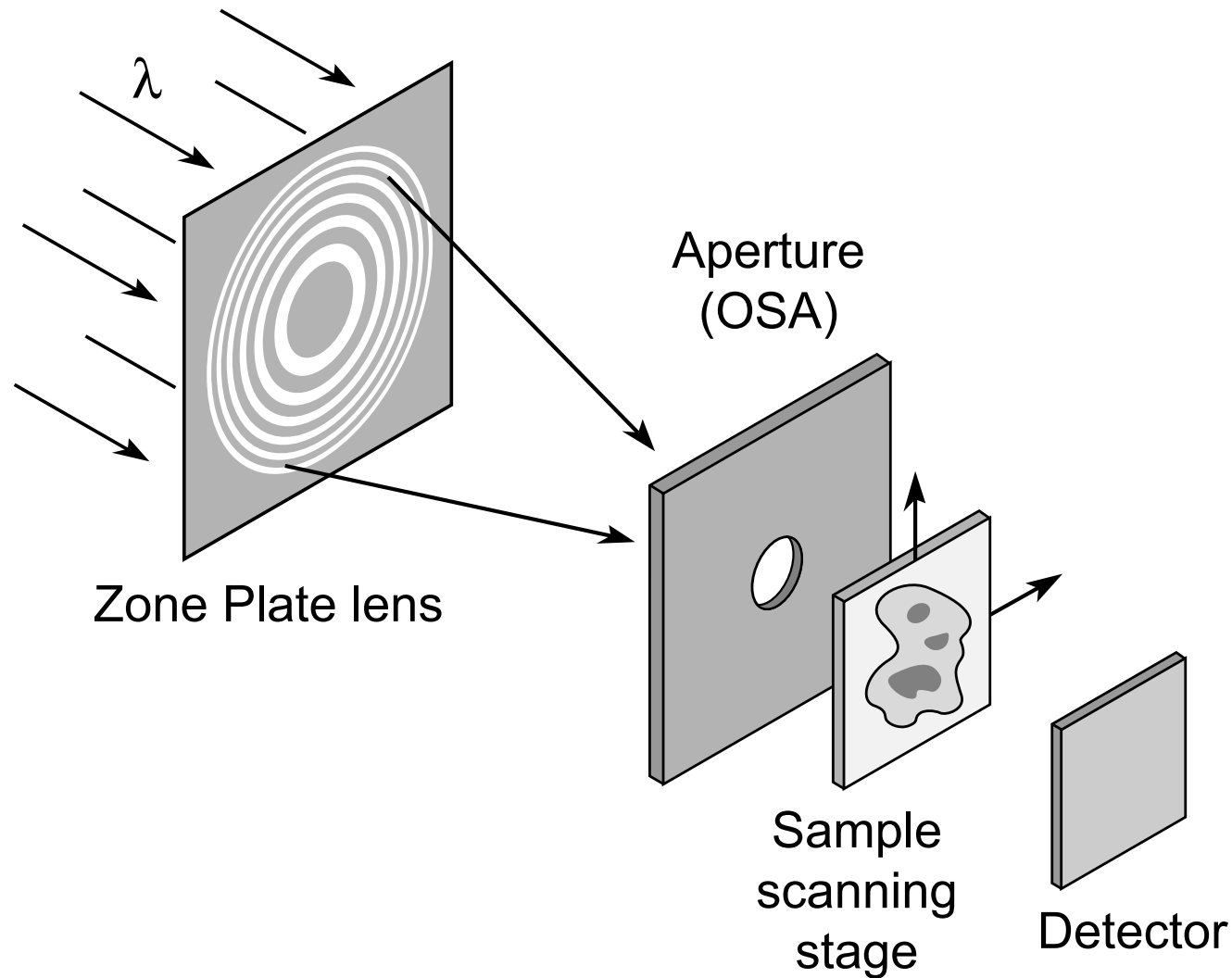
Spatial Coherence Measurements of Undulator Radiation Using the Classic 2-Pinhole Technique



Courtesy of Chang Chang, UC Berkeley and LBNL.



The Scanning Soft X-Ray Microscope Requires Spatially Coherent Illumination

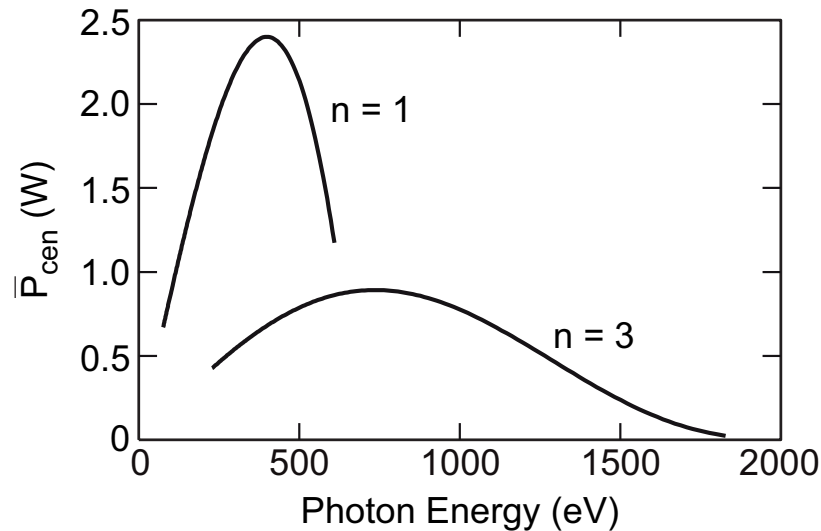




Coherent Power for an EPU at the ALS



U5 EPU



1.9 GeV, 400 mA

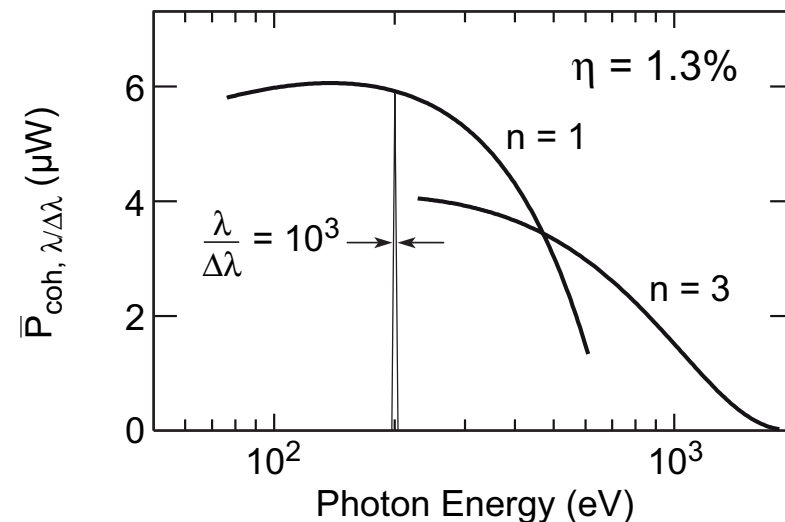
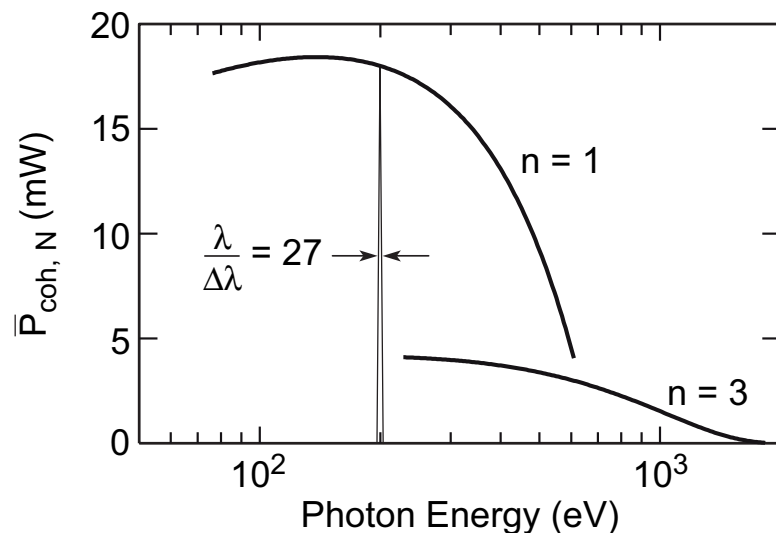
$\lambda_u = 50$ mm, $N = 27$

$0.5 \leq K \leq 4.0$

$\sigma_x = 260$ μm , $\sigma_x' = 23$ μr

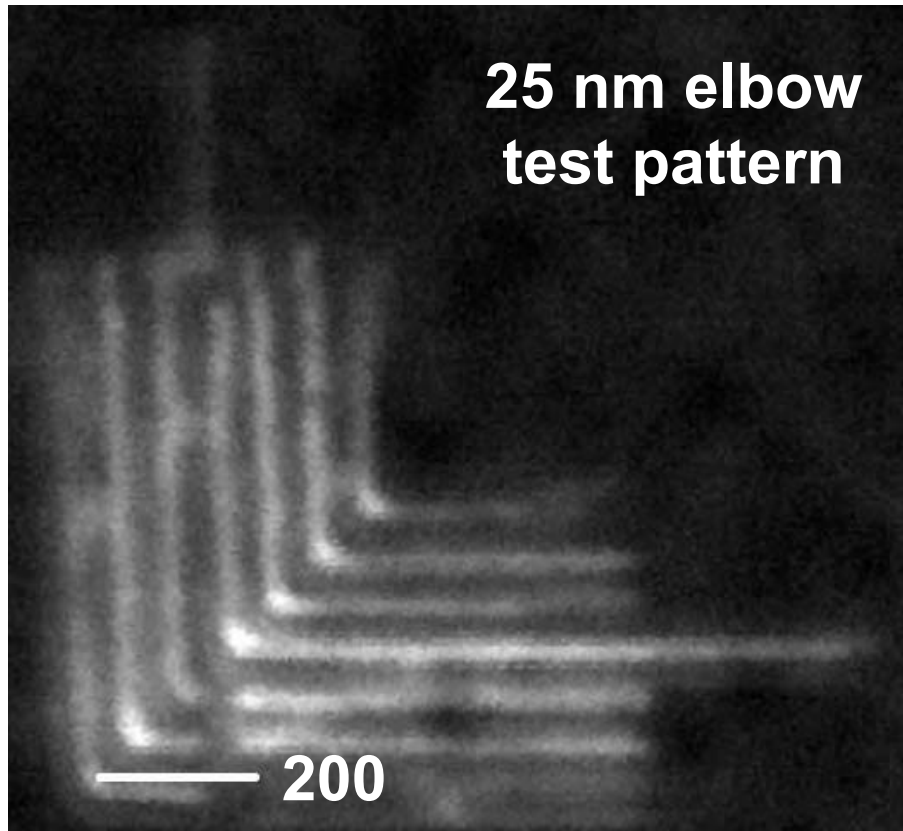
$\sigma_y = 16$ μm , $\sigma_y' = 3.9$ μr

$\theta_{\text{cen}} = 61 \mu\text{r}$ @ $K = 0.87$ (500 eV)





Spectromicroscopy: High Spatial and High Spectral Resolution Studies of Surfaces and Thin Films



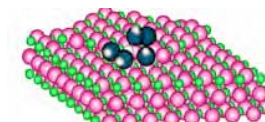
Scanning Soft X-Ray
Microscope

ALS beamline 11.0.2
395 eV; $\lambda/\Delta\lambda \approx 6000$
240 × 240 pixels
1.2 μm × 1.2 μm
2 ms dwell time

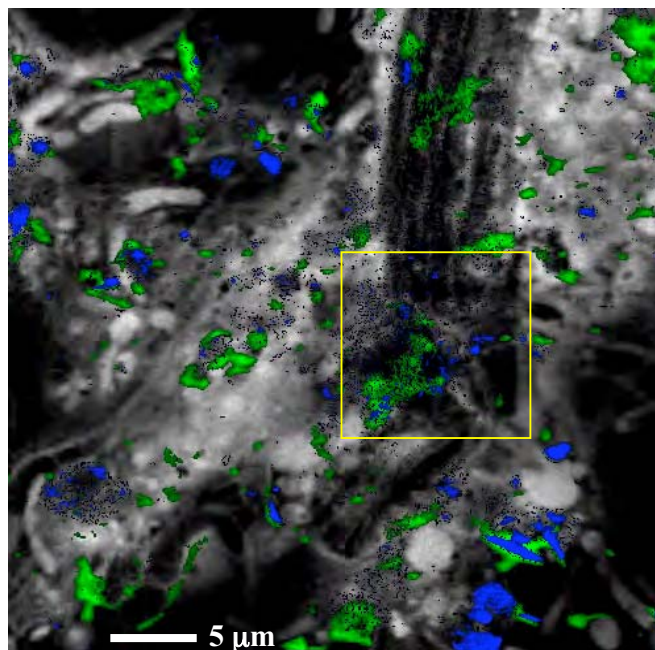
Courtesy of Tolek Tyliczszak (Dec. 2003)



Biofilm from Saskatoon River



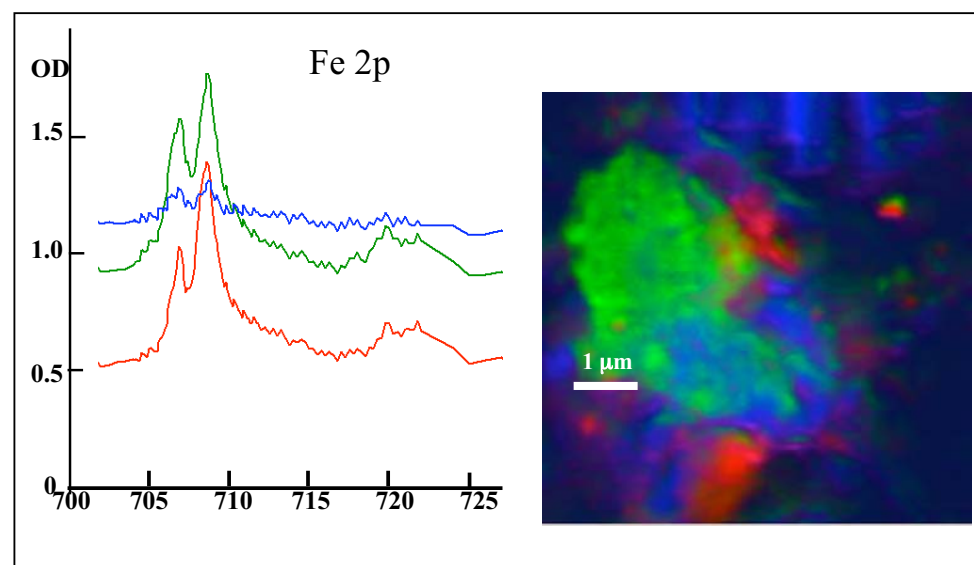
ALS-MES 11.0.2



Protein (gray), Ca, K

RESULTS

- Ni, Fe, Mn, Ca, K, O, C elemental map, (there was no sign of Cr.)
- Different oxidation states for Fe and Ni



Different oxidation states (minerals) found for Fe & Ni

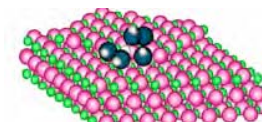
Tohru Araki, Adam Hitchcock (McMaster University)

Tolek Tyliczszak, LBNL

Sample from: John Lawrence, George Swerhone (NWRI-Saskatoon), Gary Leppard (NWRI-CCIW)

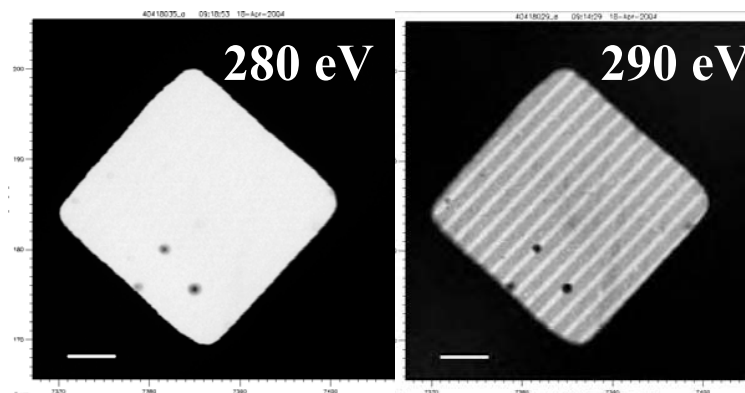


Patterned Polymer Photoresists

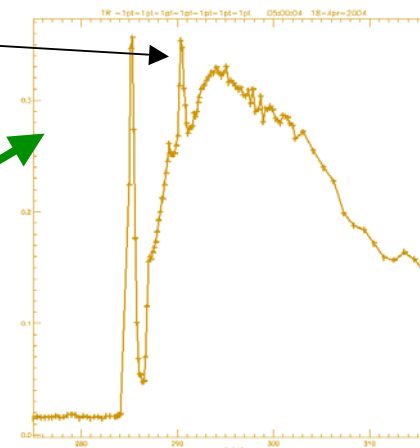
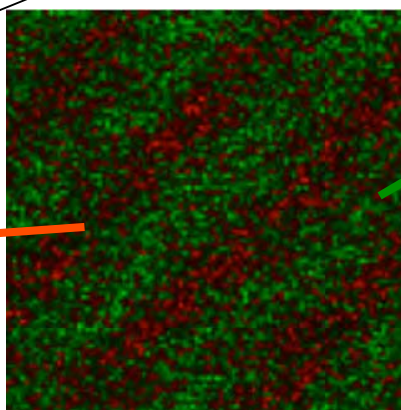
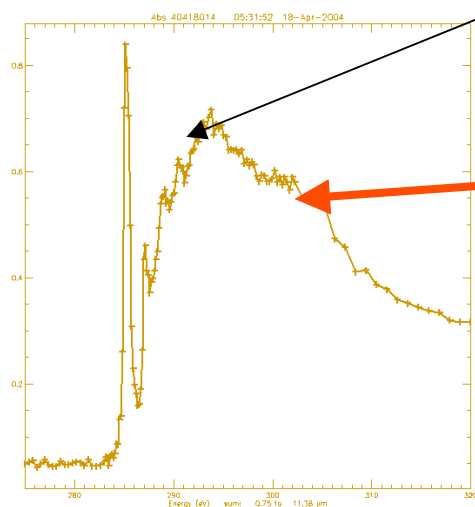


ALS-MES 11.0.2

M.K. Gilles, R. Planques, S.R. Leone
LBNL
Samples from B. Hinsberg, F. Huele
IBM Almaden



Exposure to UV light results in loss of carbonyl peak



Map chemical spectra taken of pure samples
Onto a sample containing both components

Courtesy of Mary Gilles, LBNL

16 December 2004

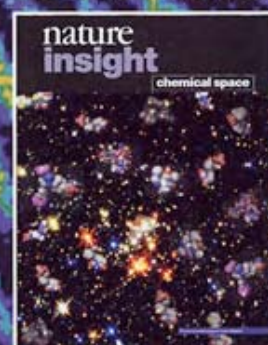
International weekly journal of science

nature

\$10.00

www.nature.com/nature

Inside this week



X-ray holography

Lensless imaging at the nanoscale

The 'Halloween storm'
How the Sun plays its tricks

Protein transport
Escape from the nucleus

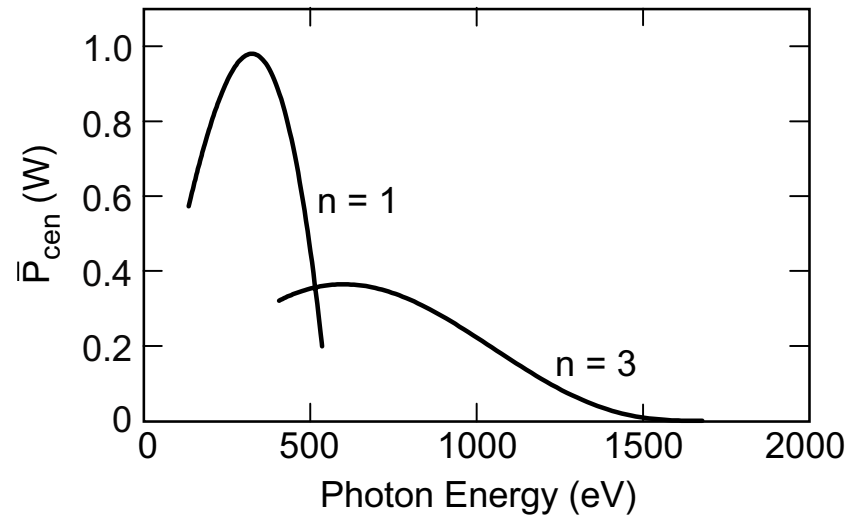
Duck-billed platypus
Curiouser and curiouser

Locusts over Africa
Time for biological control?

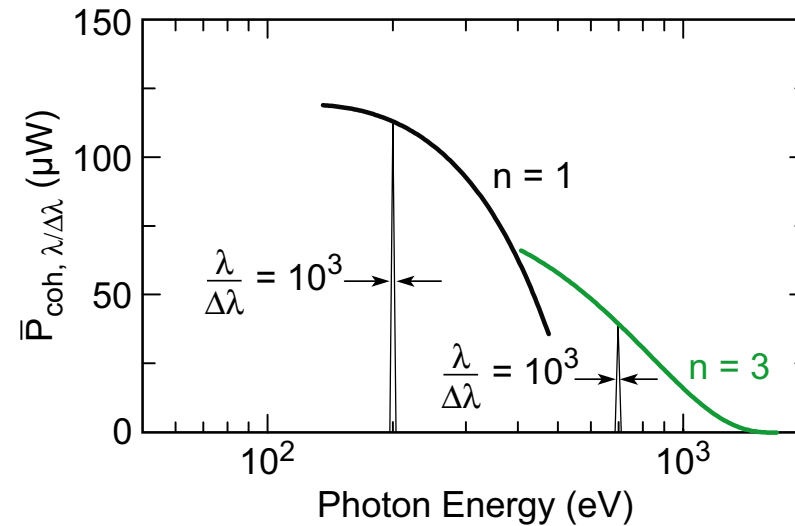
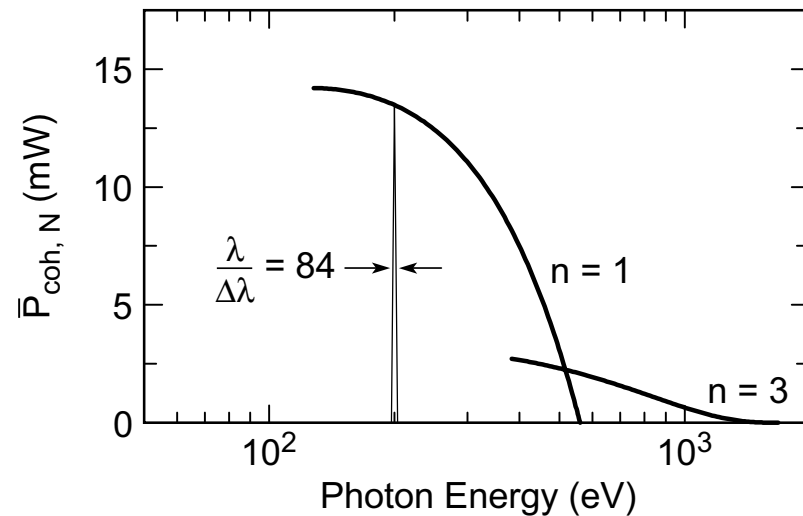




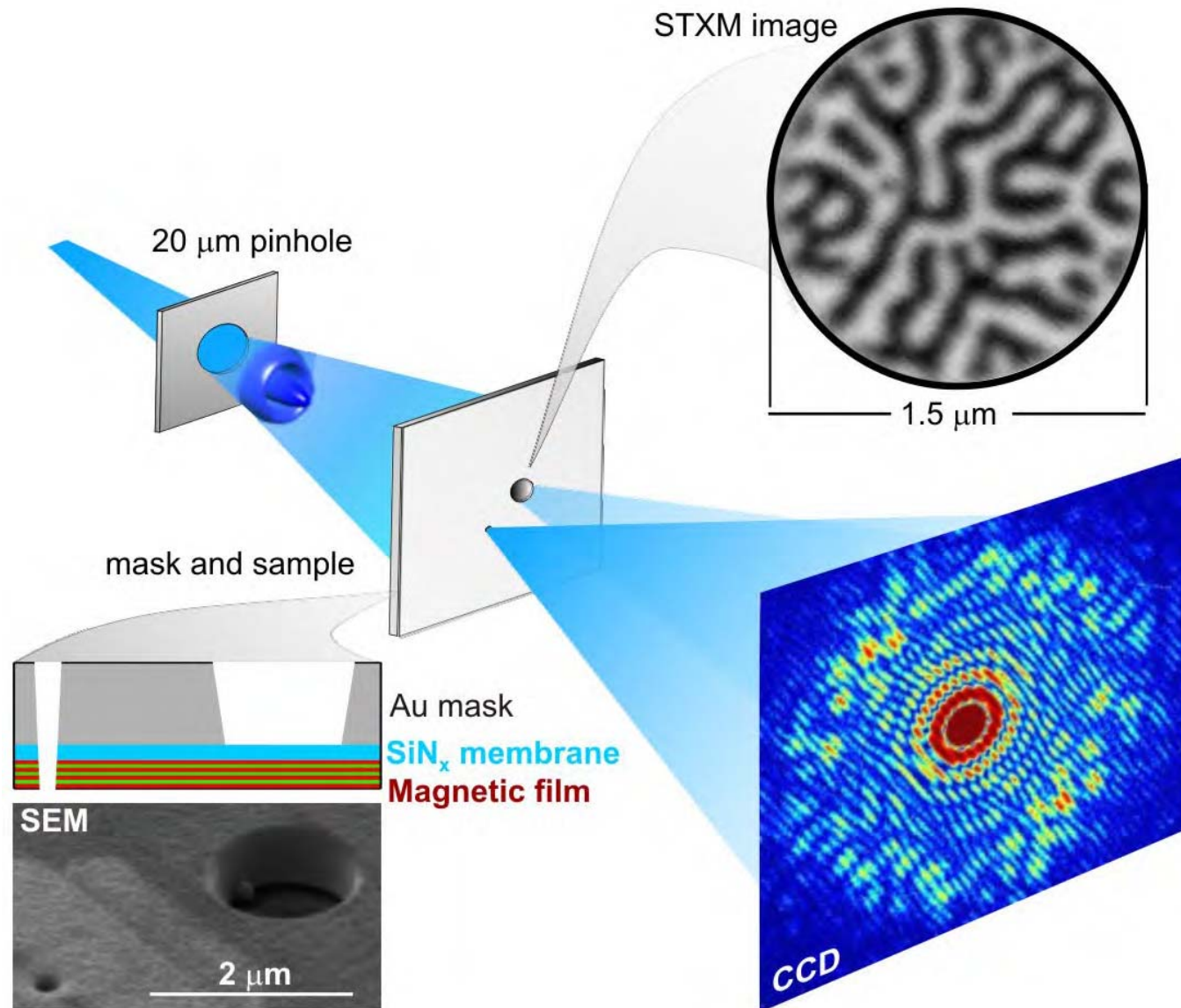
Coherent Power at BESSY II



1.7 GeV, 200 mA
 $\lambda_u = 49$ mm, $N = 84$
 $0 \leq K \leq 2.5$
 $\sigma_x = 314$ μm , $\sigma_x' = 18$ μr
 $\sigma_y = 24$ μm , $\sigma_y' = 2$ μr
 $\eta_{\text{euv}} = 10\%$; $\eta_{\text{sxr}} = 10\%$



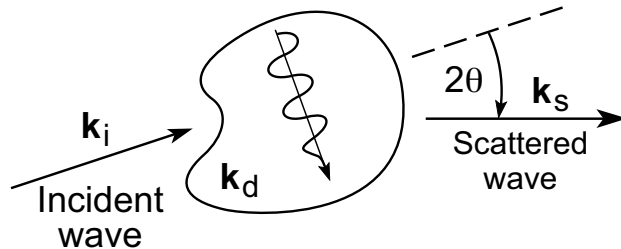
Lensless Imaging of Magnetic Nanostructures by X-Ray Spectro-Holography



S. Eisebitt, J. Lüning, W.F. Schlotter, M. Lörger, O. Hellwig,
W. Eberhardt & J. Stöhr / *Nature*, 16 Dec 2004

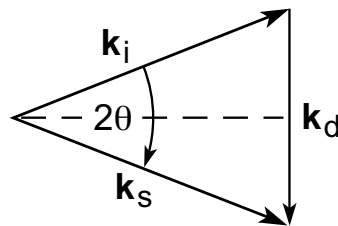


Coherent Soft X-Ray Scattering



$|\mathbf{k}_d| = 2\pi/d$ represents a spatial non-uniformity in the medium, such as atoms of periodicity d , a grating, or a density distribution due to a wave motion.

If the density distribution is stationary, or near stationary, the scattering diagram is isosceles.

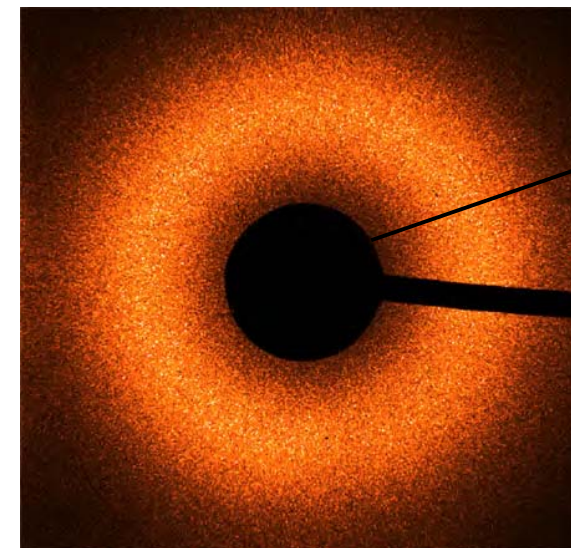


$$\hbar\omega_s = \hbar\omega_i + \hbar\omega_d$$

$$\hbar\mathbf{k}_s = \hbar\mathbf{k}_i + \hbar\mathbf{k}_d$$

- At a given angle one detects scattering from fluctuations of a specific spatial scale
- At that angle, the frequency content tells you the time structure of those fluctuations

Coherent Scattering from a Pt:Co Multilayer

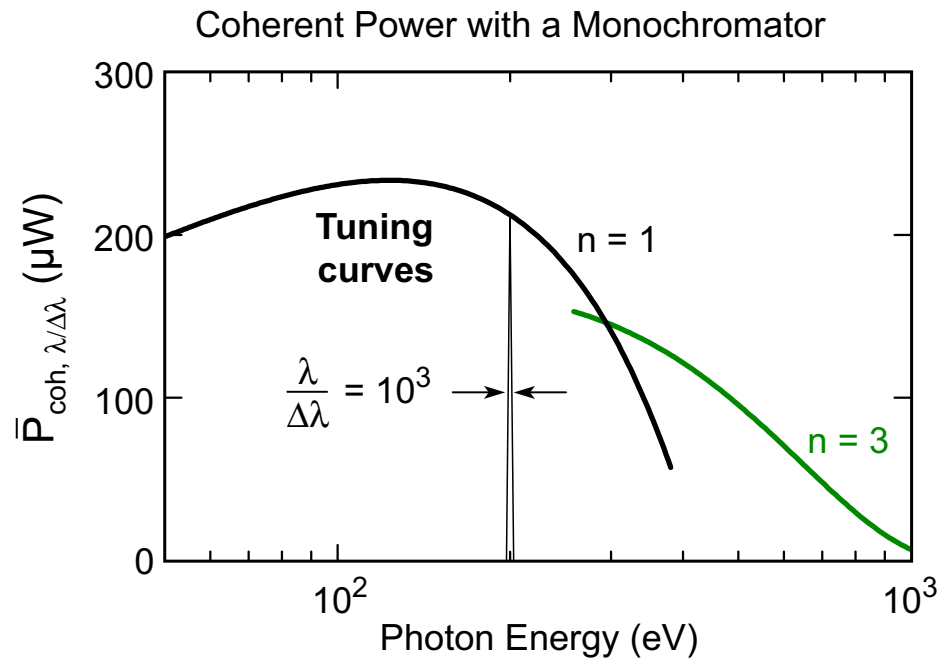
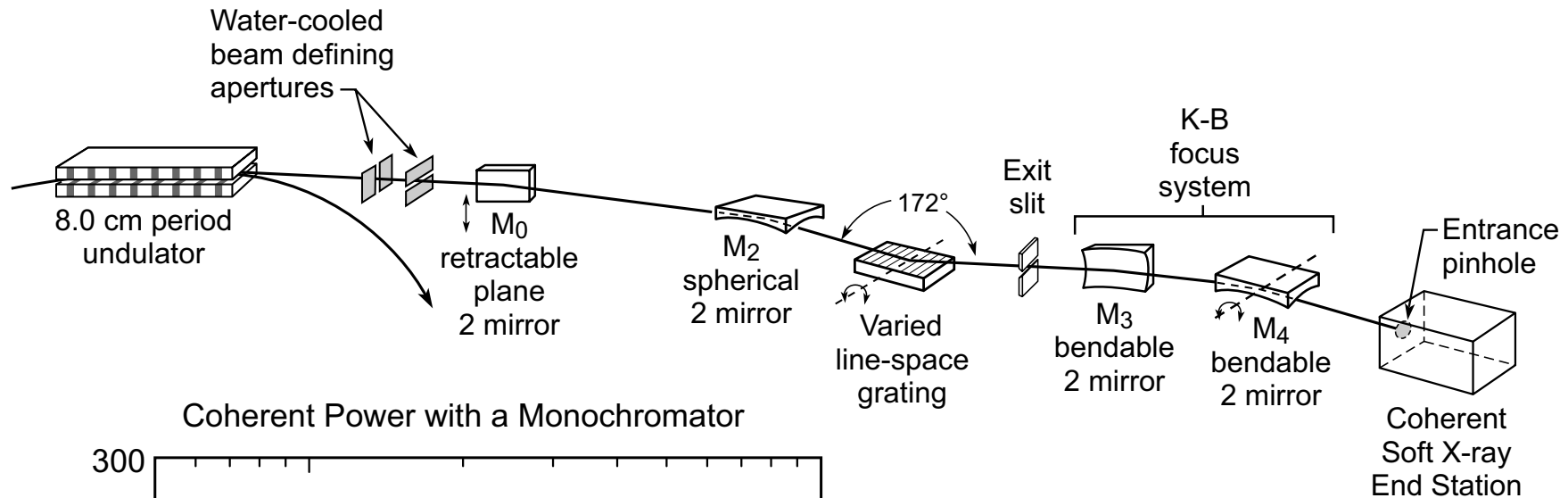


Soft x-ray speckle pattern: diffraction pattern of the magnetic domain structure

(Courtesy of Steve Kevan, University of Oregon)



Coherent Soft X-Ray Beamline: Use of a Higher Harmonic ($n = 3$) to Access Shorter Wavelengths



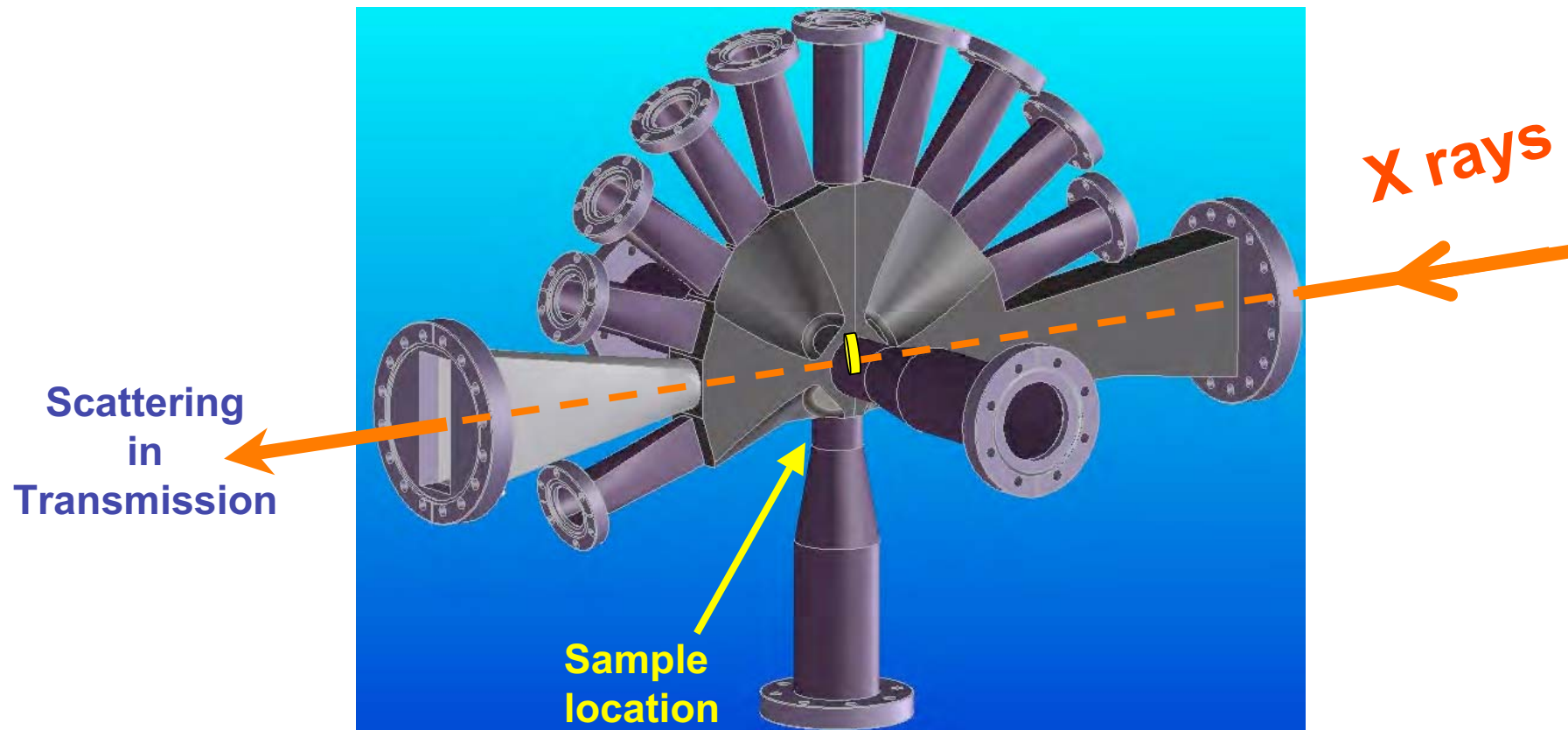
8.0 cm period, $N = 55$
1.9 GeV, 400 mA
 $d \cdot \theta = \lambda/2\pi$
 $\ell_{\text{coh}} = 1000 \lambda/2$
 $\eta_{\text{euv}} = 10\%$, $\eta_{\text{sxr}} = 10\%$



Coherent Soft X-Ray Magnetic Scattering Endstation



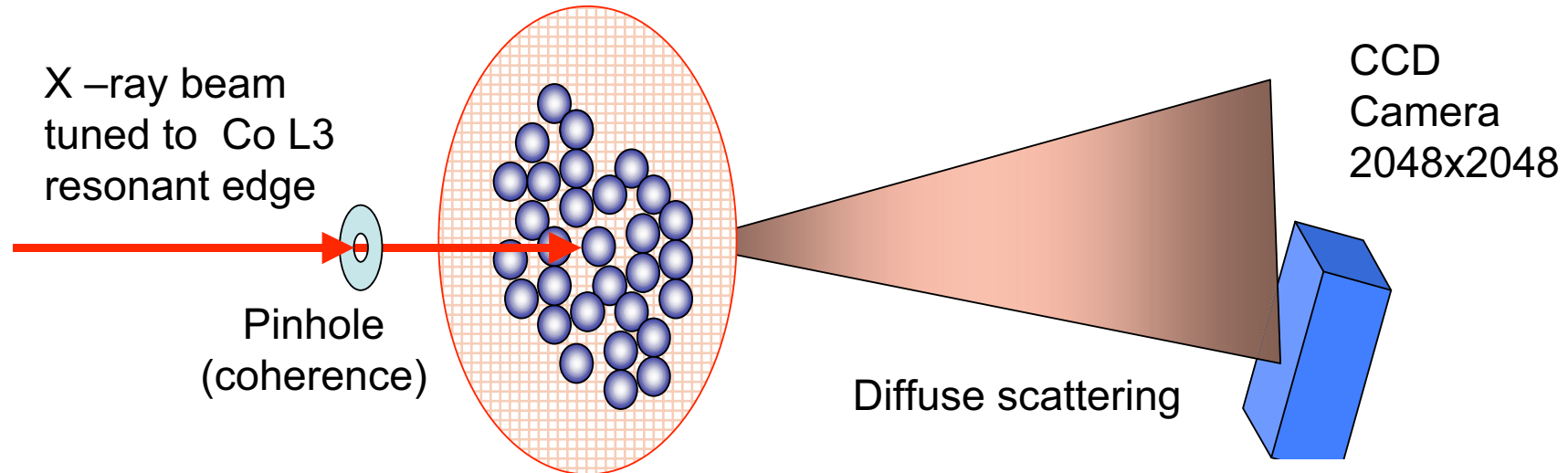
Flangosaurus



Courtesy of K.Chesnel, S. Kevan, U. Oregon

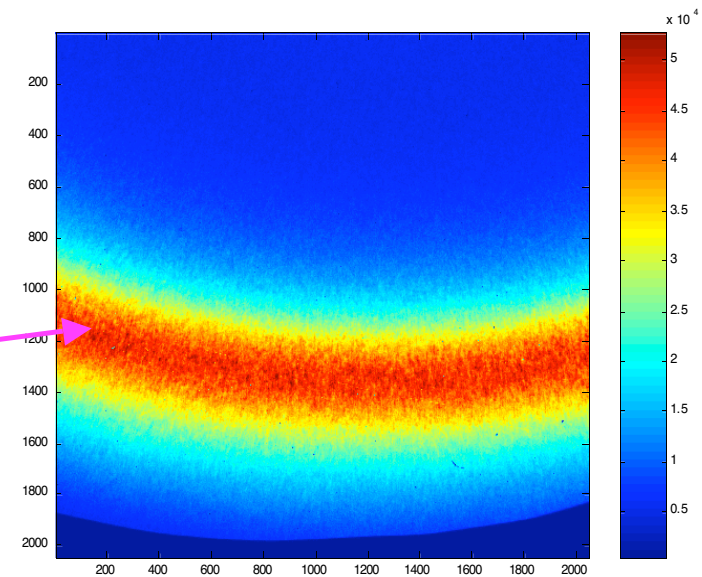


Example of Experiment in Transmission: Coherent Scattering from Nanoparticles



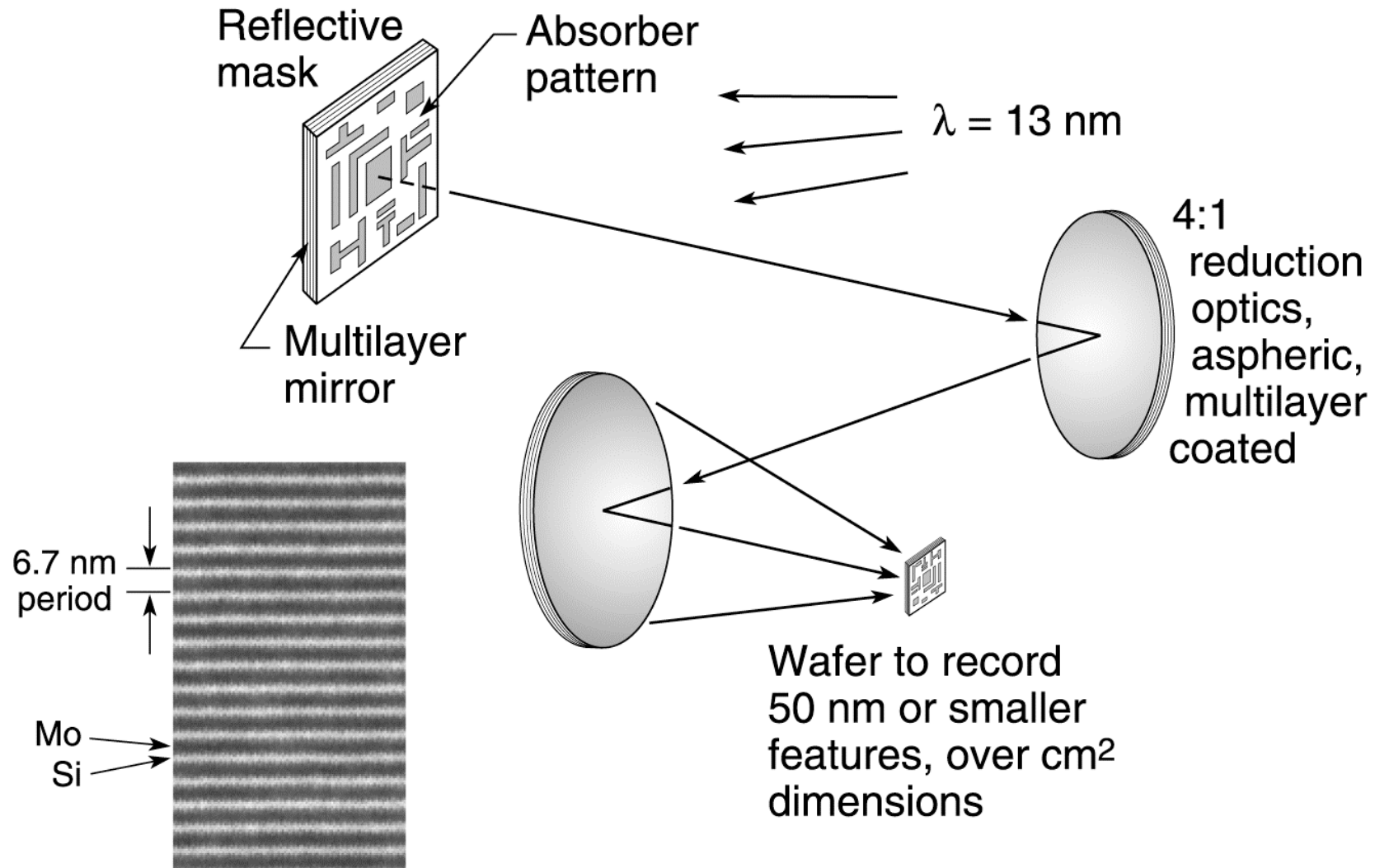
Co Nanoparticles assembly
precipitated on TEM grid

Scattering ring
related to
interparticle distance
 $\sim 12\text{nm}$



Courtesy of K.Chesnel, S. Kevan, U. Oregon

Extreme ultraviolet (EUV) lithography based on multilayer coated optics





International Technology Roadmap for Semiconductors[†]



First year of volume production	2003* 2004	2005* 2007	2008* 2010	2010* 2013	2012* 2016
Technology Generation (half pitch, 1:1, printed in resist)	90 nm	65 nm	45 nm	32 nm	22 nm
Isolated Lines (in resist) [Physical gate, metalized]	53 nm [37 nm]	35 nm [25 nm]	25 nm [18 nm]	18 nm [13 nm]	13 nm [9 nm]
Chip Frequency	2.5 GHz	4.9 GHz	9.5 GHz	19 GHz	36 GHz
Transistors per chip (HV) (3 × for HP ; 5 × for ASICs)	190 M	390 M	770 M	1.5 B	3.1 B
DRAM Memory (bits per chip)	1.1 G	2.2 G	4.3 G	8.6 G	34 G
Field Size (mm × mm)	22 × 32	22 × 32	22 × 32	22 × 32	22 × 32
Wafer Size (diameter)	300 mm	300 mm	300 mm	450 mm	450 mm

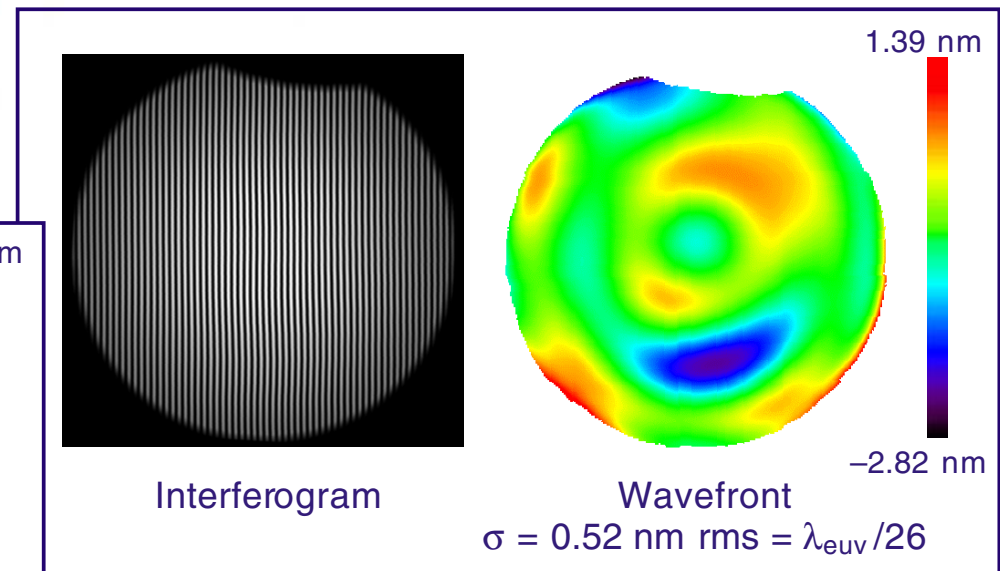
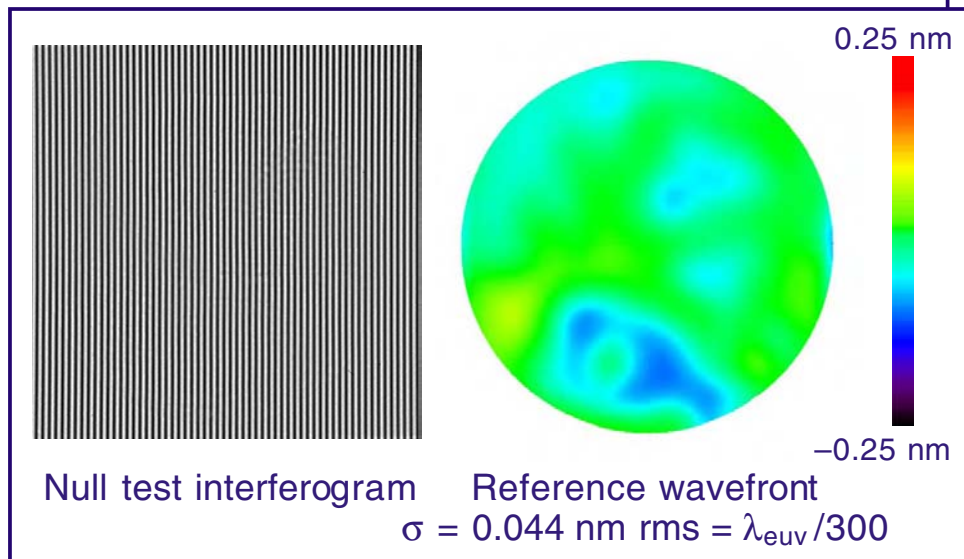
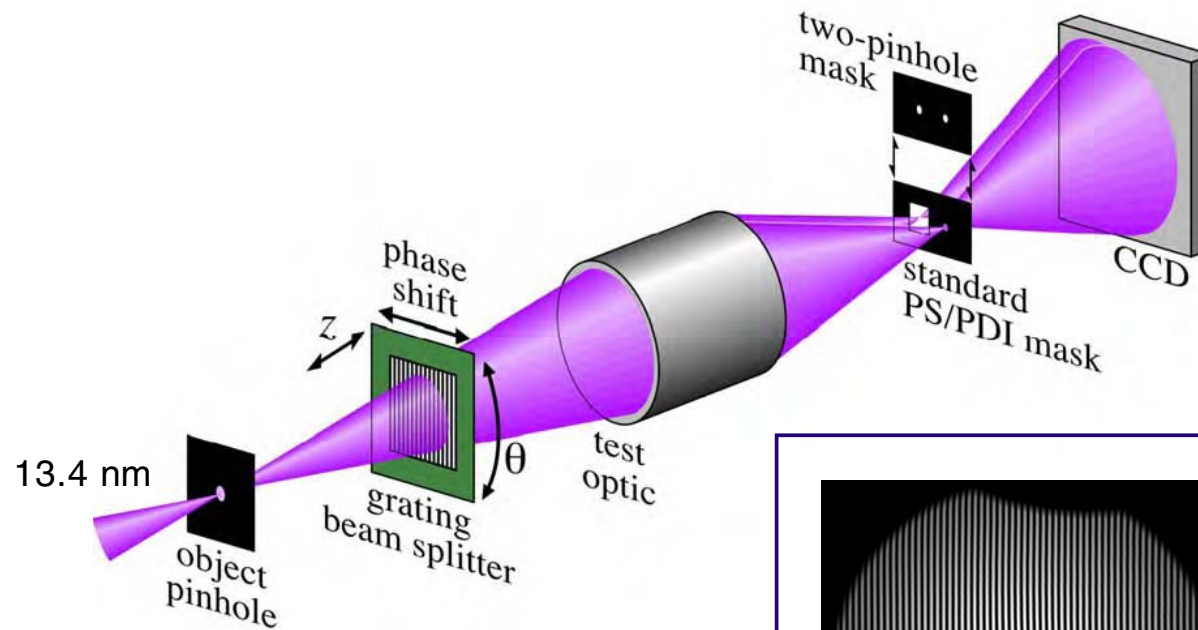
[†]Semiconductor Industry Association (SIA), December 2004 update.

***Possible 2-year cycle for leading edge companies.**

SIA_Rdmp_2008.ai

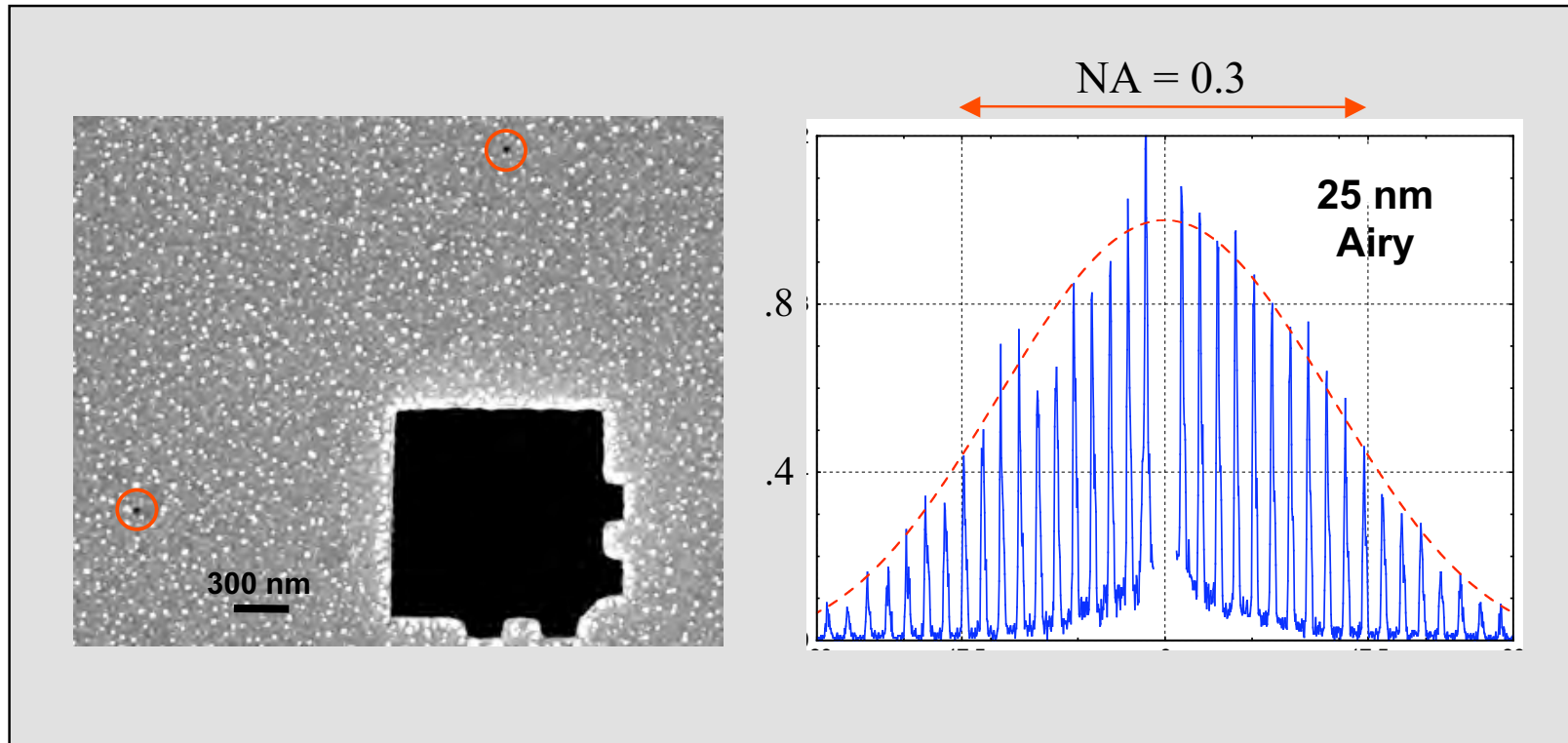


Coherent Undulator Radiation Used for Interferometry Testing Multilayer Coated Optics for EUV Lithography



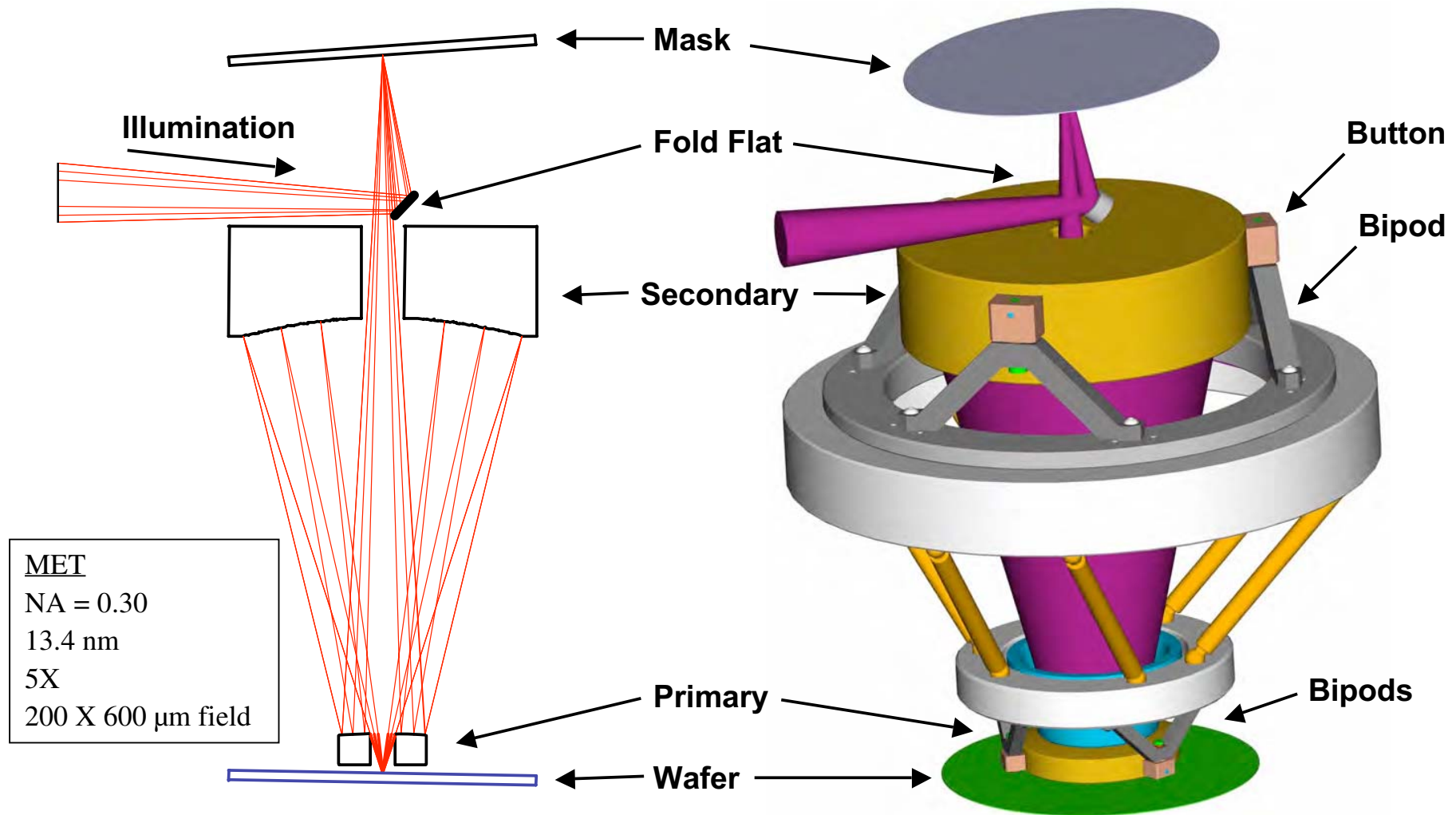


25 nm Pinholes for 0.3 NA EUV Interferometry



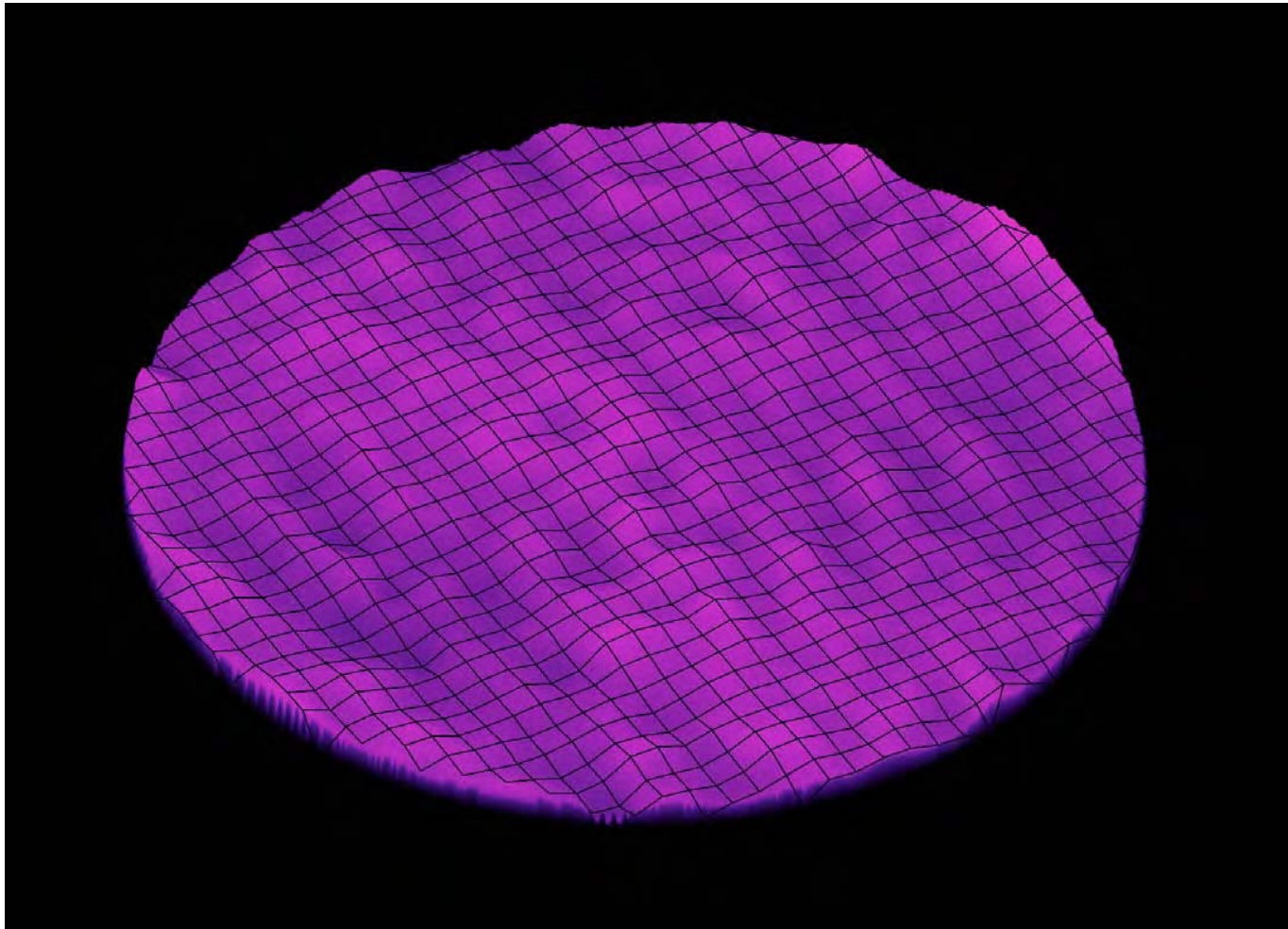
Courtesy of E. Gullikson, E. Anderson and K. Goldberg, LBNL.

A 0.30 NA Micro-Exposure Tool (MET) for Testing EUV Resist Patterns to 12 nm Feature Size

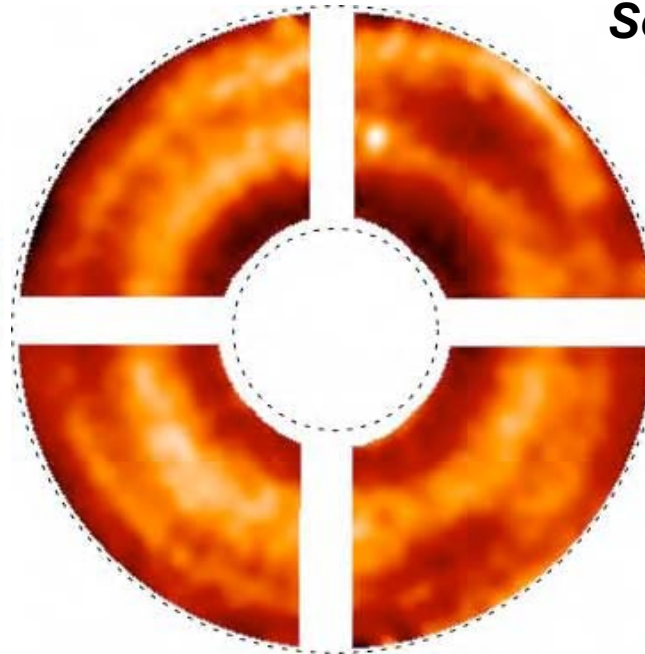
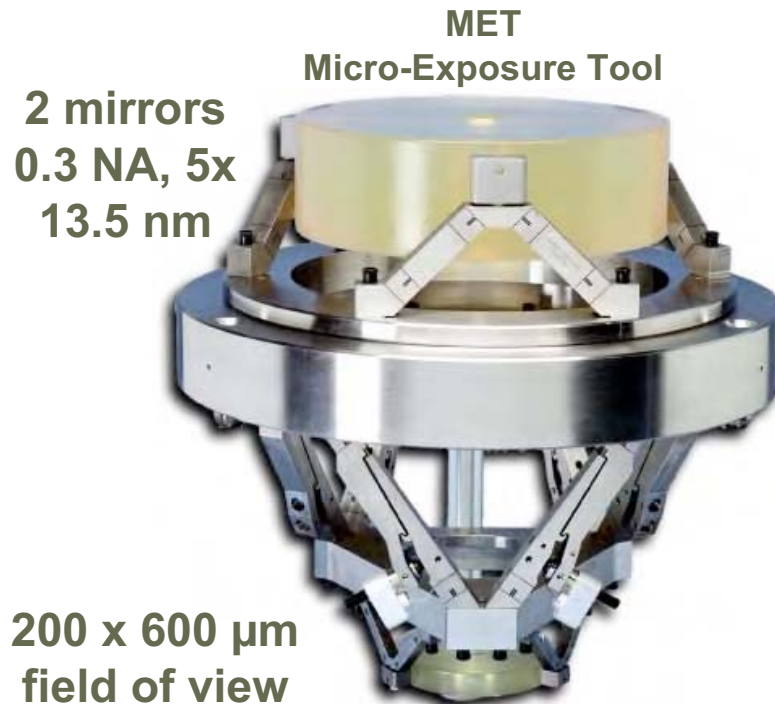


(Courtesy of J. Taylor, LLNL)

EUV wavefront measurements to $\lambda_{\text{euv}}/300$



MET At-Wavelength Interferometry and Alignment Preparation for Static Microfield Imaging



Alignment in progress
September 3, 2003

central field point

astig 0.1 nm

coma 0.3 nm

sph ab 0.4 nm

trifoil 0.2 nm

h-o s. 0.4 nm

RMS 0.8 nm

$\lambda/17$

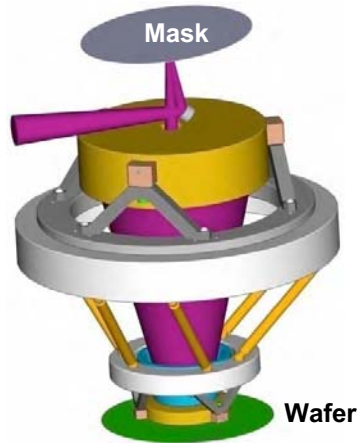
**aberrations
may be reduced
in final alignment**

- Visible-light alignment at Livermore
- EUV interferometry at Berkeley includes PS/PDI and shearing at 9 points across the field of view and in z.
- Higher-order spherical aberration dominates the wavefront
- A large part of the higher-order spherical is contained in Z35 and Z36. Higher-order spherical magnitude depends strongly on NA.

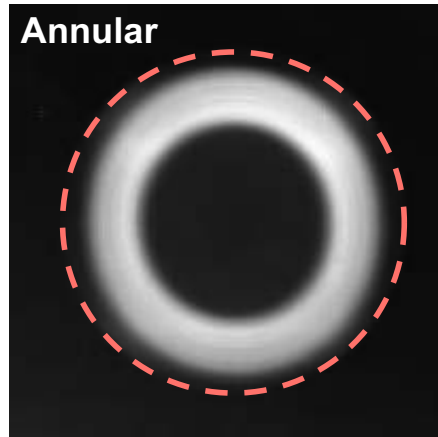


Addressing critical EUV lithography issues for Sematech at the ALS: testing state-of-the-art EUV resists

Two-bounce, 0.3 NA, MET at ALS Beamline 12.0



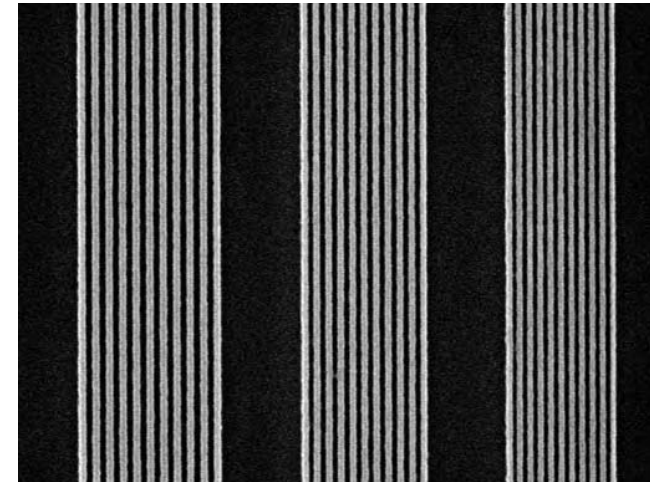
Programmable illumination



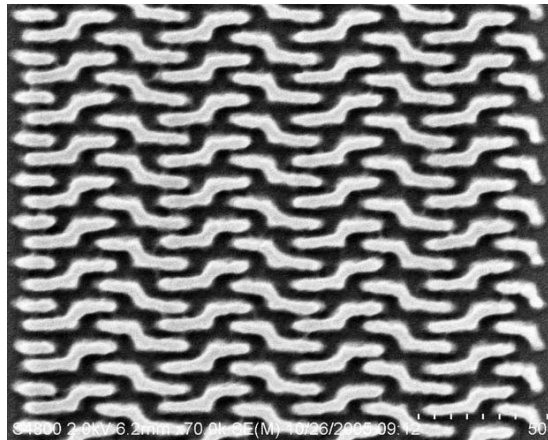
45 nm

40 nm

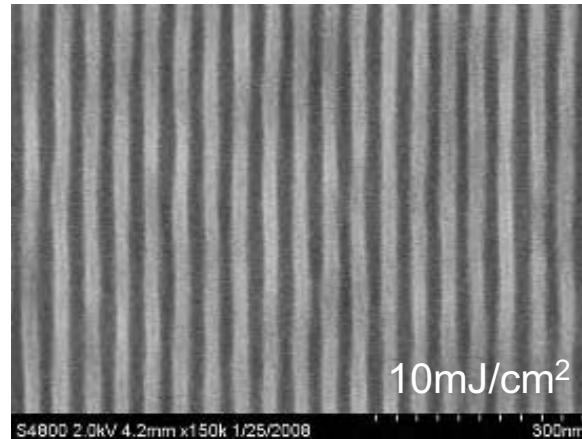
35 nm



35 nm



22 nm lines and spaces



Significant issue for EUV lithography

When will EUV resists be available with combined high spatial resolution (20 nm), high sensitivity (10 mJ/cm²), and low line edge roughness (LER, 1.2 nm)?

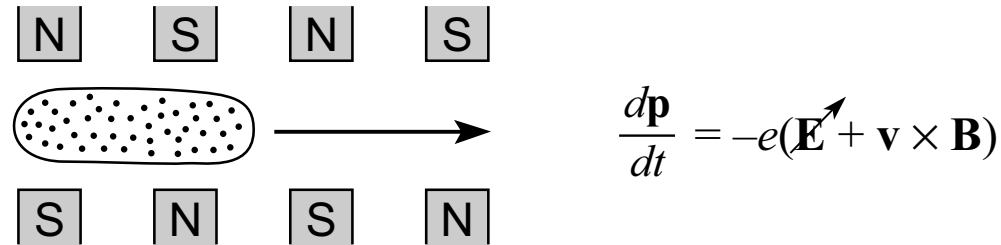
Major support and collaborators include Sematech, Intel, AMD, IBM, Samsung and others.

Courtesy of Patrick Naulleau, CXRO/LBNL.

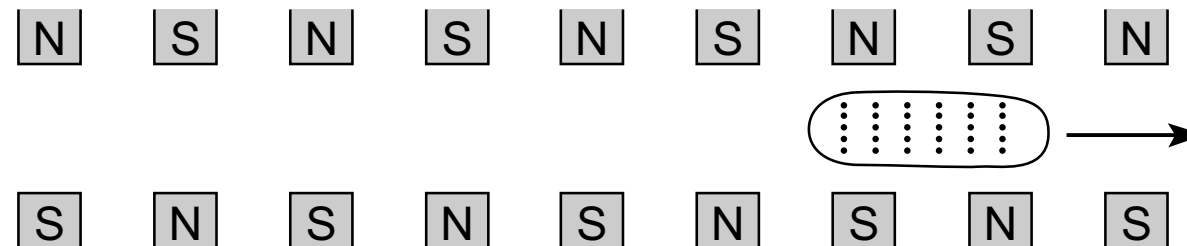




Undulators and FELs



Undulator – uncorrelated electron positions, radiated fields uncorrelated, intensities add, limited coherence, power $\sim N$.

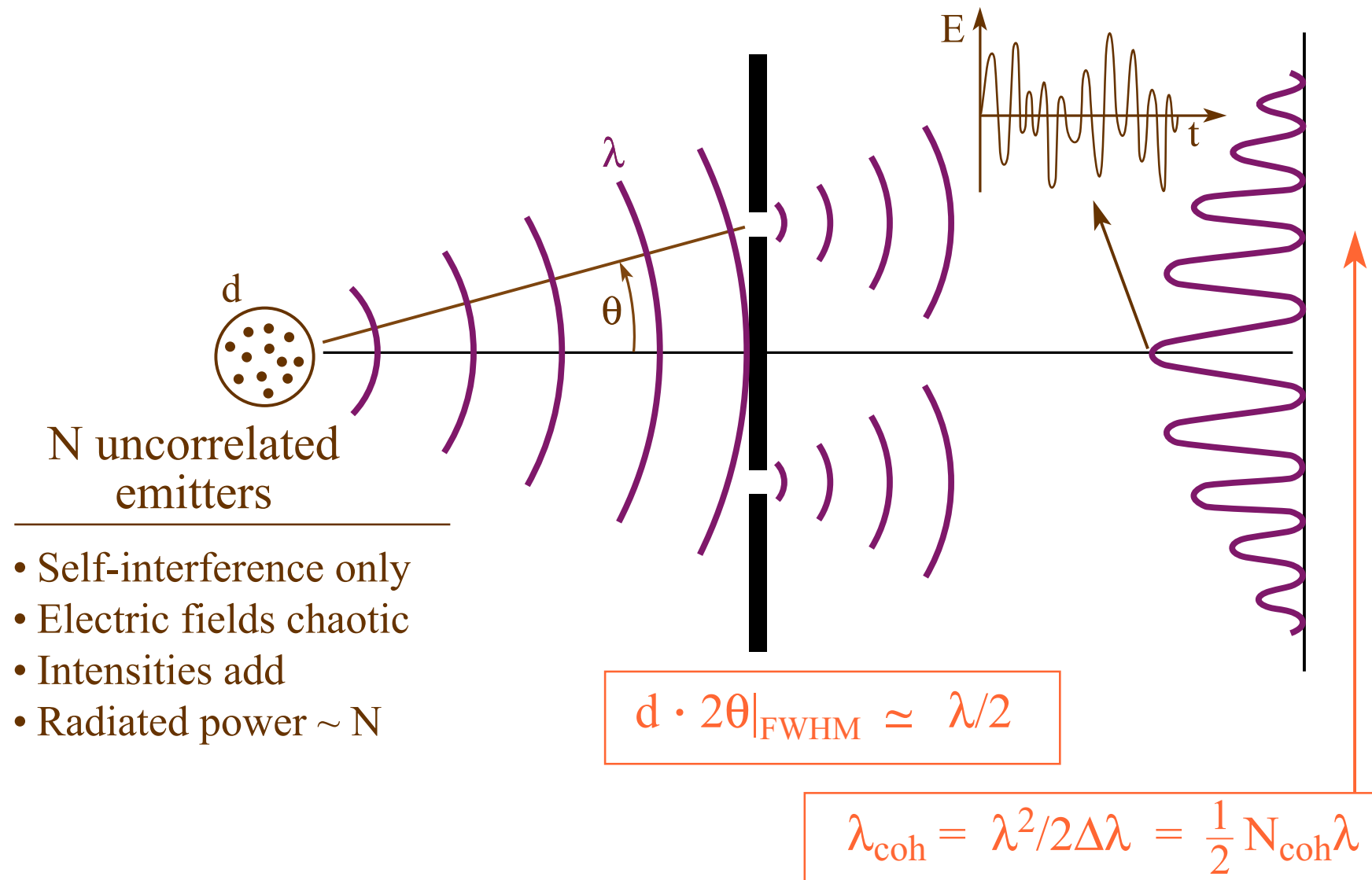


Free Electron Laser (FEL) – very long undulator, electrons are “microbunched” by their own radiated fields into strongly correlated waves of electrons, all radiated electric fields now add, spatially coherent, power $\sim N^2$

$$\frac{d\mathbf{p}}{dt} = -e(\mathbf{E} + \mathbf{v} \times \mathbf{B})$$

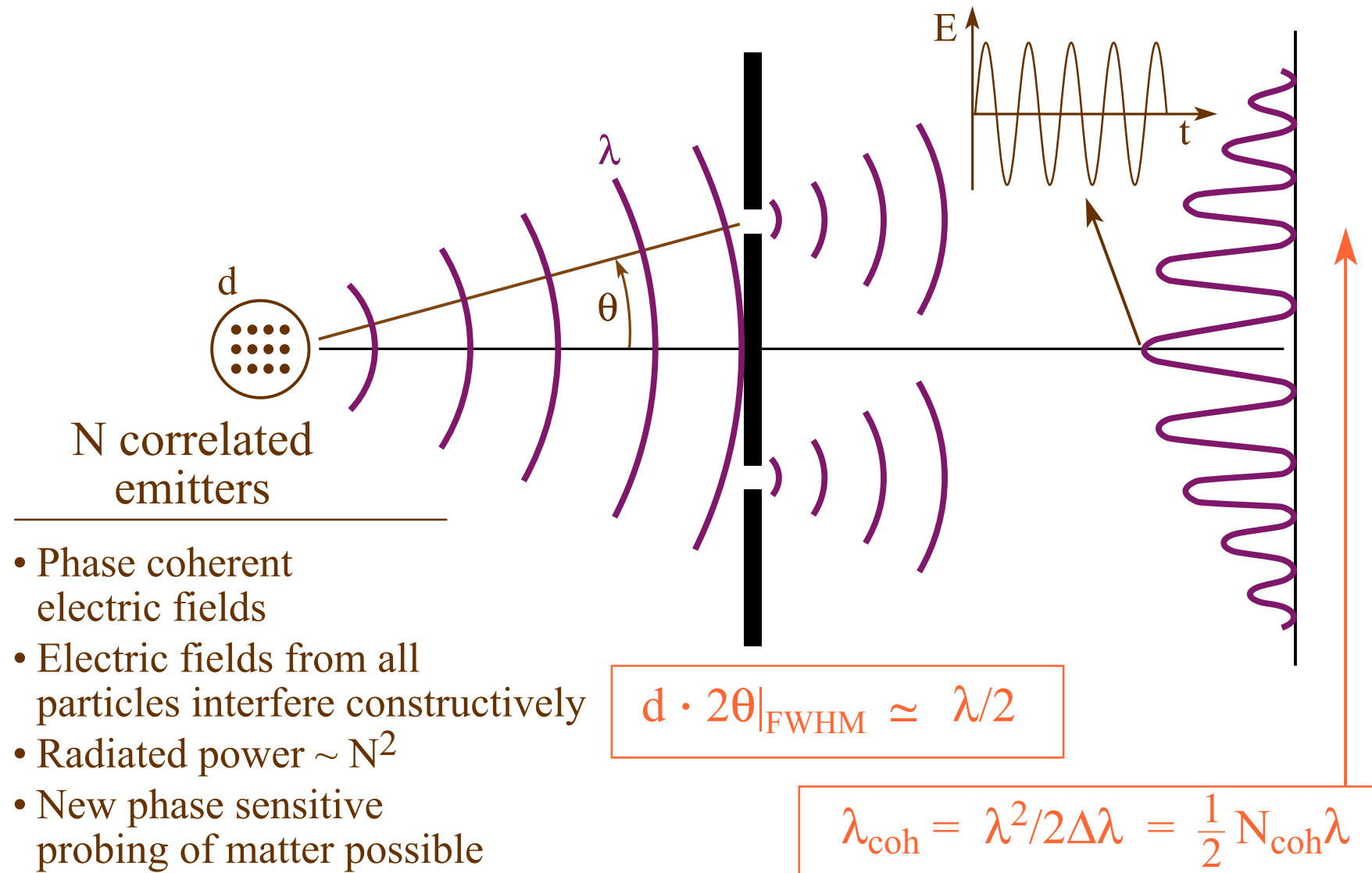


Young's Double Slit Experiment with Random Emitters: Young did not have a laser



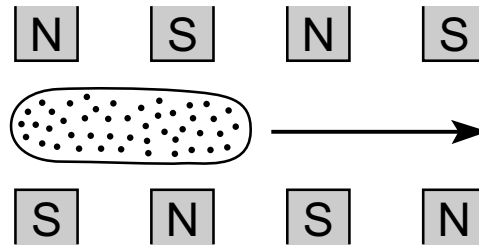


Young's Double Slit Experiment with Phase Coherent Emitters (some lasers, or properly seeded FELs)





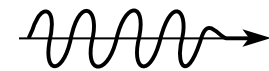
Seeded FEL

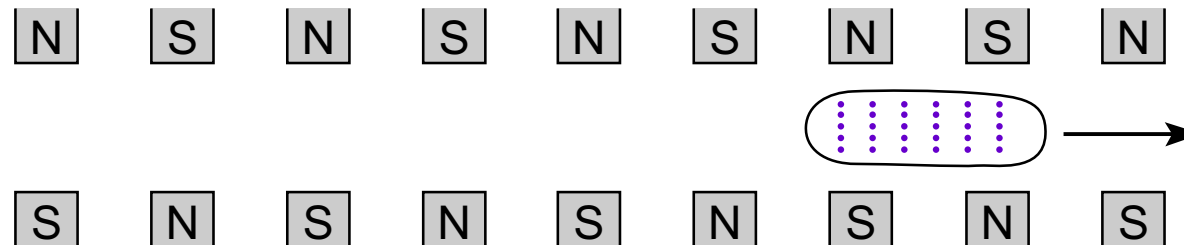


$$\frac{d\mathbf{p}}{dt} = -e(\mathbf{E} + \mathbf{v} \times \mathbf{B})$$

Undulator – uncorrelated electron positions, radiated fields uncorrelated, intensities add, limited coherence, power $\sim N$.

Better electron distribution throughout bunch, resulting in better coherence properties.


Coherent seed pulse



Free Electron Laser (FEL) – very long undulator, electrons are “microbunched” by their own radiated fields into strongly correlated waves of electrons, all radiated electric fields now add, spatially coherent, power $\sim N^2$

$$\frac{d\mathbf{p}}{dt} = -e(\mathbf{E} + \mathbf{v} \times \mathbf{B})$$

FLASH EUV/soft x-ray FEL at DESY Lab, Hamburg



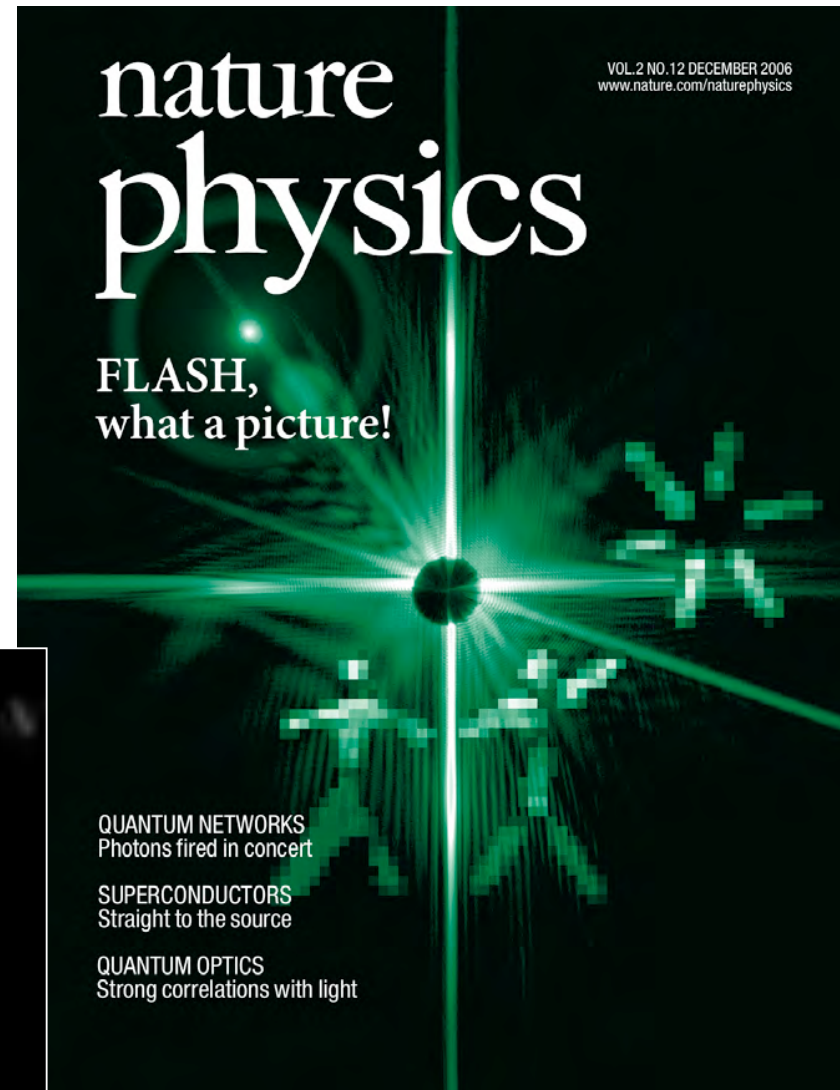
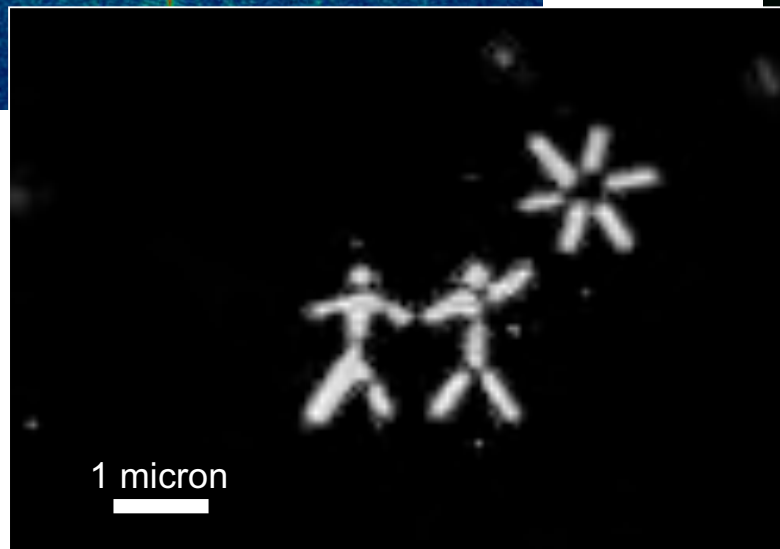
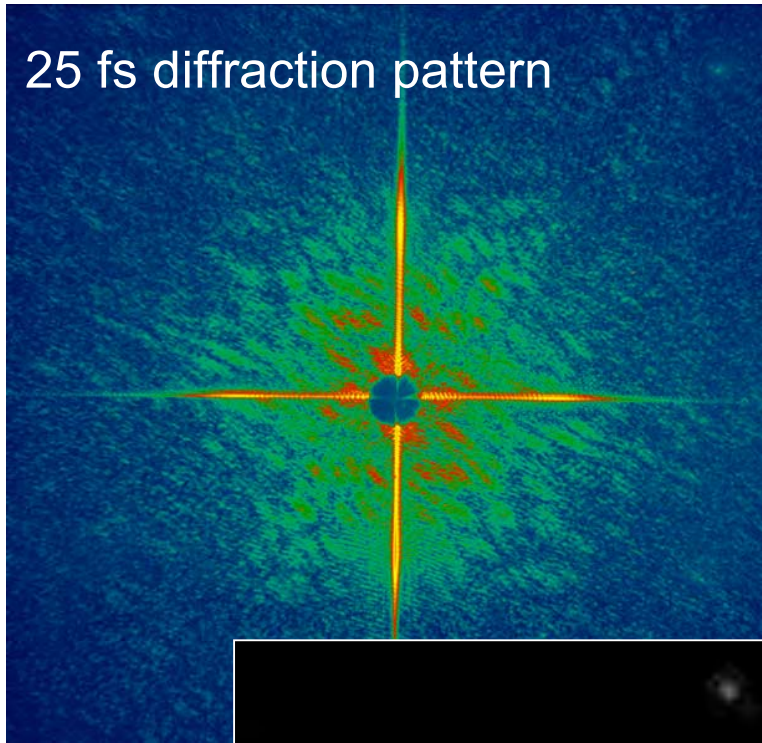
6.5-32 nm wavelength in 1st harmonic
20 fsec, 10^{12} photons per pulse

Courtesy of Henry Chapman (LLNL, now Hamburg) and Stefano Marchesini (LLNL, now LBL).

Coherent X-ray Diffractive Imaging with the FLASH free-electron laser (FEL) in Hamburg, Germany



25 fs diffraction pattern



Chapman et al, *Nature Phys* **2** 839 (2006)



UC Berkeley

www.coe.berkeley.edu/AST/sxreu

www.coe.berkeley.edu/AST/srms

